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SUBMINIATURE TUBES - PREDICTION OF FAILURE AND LIFE TESTING UNDER NORMAL AND OVERLOAD CONDITIONS

by

HORACE PHILLIPS McNEAL

An Essay

submitted to the Advisory Board

of The School of Engineering

of

The Johns Hopkins University

in conformity with the requirements for

the Degree of Master of Engineering.

Baltimore Maryland

May 1949

SUPERSTRUCTURE TRUSS - FORMULATION OF VARIOUS AND
LIKELY LOADING MODELS FOR AXIAL AND CYCLICAL CONDITIONS

by

NORMAN PHILLIPS MORRIS

A Thesis

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Vita

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SUBMINIATURE TUBES - PREDICTION OF FAILURE AND LIFE TESTING UNDER NORMAL AND OVERLOAD CONDITIONS

Chapter I

Introduction

The purpose of this investigation is threefold. First, to make static tests on subminiature tubes, collecting as much data as possible on their behavior at different values of heater voltage and at different values of plate voltage; and to compare uniformity of the same type tube made by two different manufacturers. Second, to make dynamic tests on the same tubes in a circuit which simulates their use in an actual amplifier. The purpose of these tests is to determine tube life, or changes in tube characteristics, under normal load and overload conditions. Third, to attempt to correlate the results of the static tests with the results of the dynamic tests and discover some

method by which static testing may be used to accurately predict which tubes may fail under overload; or to prove that no simple criterion exists for such prediction.

The investigation was sponsored by the Telemetering Group of The Applied Physics Laboratory, The Johns Hopkins University, Silver Spring, Maryland, which supplied the subminiature tubes to be tested, approximately 100 each of the following types: a) Manufacturer "A" - Type 6K4-A General Purpose Triode, and b) Manufacturer "B" Type CK6080X Triode.

The general description of the tests to be conducted was contained in a letter to the supervisor of the Telemetering Group from the gentlemen for whom the tests were run. It described the tests as follows: "The first phase will consist of a number of measurements of the parameters of the tubes, with various electrode voltages from normal to less

than normal. The second phase will consist of running the tubes under varying conditions of overload to determine life and types of failure. The final report will attempt to correlate the predicted life with the actual life under overload. It will also show the relative merits of the 6K4-A and the CK608".

Chapter II

Description of Static Tests

The static tests consisted of the following:

a) Each tube was tested for internal short circuits.

b) Tubes were operated at rated value of heater voltage (6.3 volts A.C.) and Grid Bias voltage (-2 volts). Plate voltage was set successively at 100%, 80%, 60%, 50%, and 33.3% rated value for Manufacturer "S" Tubes and at 100%, 83.5%, 66.7%, 50%, 33.3% rated value for Manufacturer "R" Tubes. At each value of plate voltage the following quantities were recorded; Grid Bias Voltage, Heater Voltage, Plate current, Heater current, Grid current, Transconductance.

c) Tubes were operated at rated value of Plate Voltage (100volts D.C. for Manufacturer "S" Tubes, 120 volts D.C. for Manufacturer "R" Tubes). Heater voltage was set successively at 100%, 83.5%, 31.8% of rated Heater voltage (6.3

21.8% of rated heater voltage (6.3

volts A. C.). At each value of heater voltage the following quantities were recorded: Plate Voltage, Grid Bias Voltage, Plate Current, Heater Current, Grid Current, Transconductance.

Description of Tube Testing Equipment Used For Static Tests

The static tests described above were performed in a Navy Type OD-5 Tester. A brief description of this equipment follows as it appears in the Instruction Pamphlet: Model OD-5 Vacuum Tube Analyzing Equipment Supply 110-120 volts 50-60 cycles. Manufacturer: Weston Electrical Instrument Corporation.

"In brief the Model OD equipment consists of the following apparatus: A plurality of vacuum tube sockets designed to accommodate 4 pin, 5 pin, 6 pin, 7 pin, 8 pin minature and acorn tube bases; a transformer supplying 60 cycle power at one of

several standard filament potentials; patch cords for connecting filament power to any pair of socket terminals; a power rectifier supplying filtered direct potential to a system of potentiometers and thence by way of patch cords, to any desired socket terminals; a plurality of electrical indicating instruments suitable for indicating potentials between socket terminals and currents flowing through socket terminals, and a plurality of vacuum tube sockets interconnected with indicating lamps designed to indicate the presence of short circuited tube elements."

"The Model OD equipment measures transconductance by measuring the alternating current produced in the plate circuit by a 60 cycle signal applied to the grid of the tube under test. The grid signal has an effective value of one volt and as transconductance is the ratio of the value of alternating plate current to the value of the alternating grid signal which produced it, it is evident

that the instrument which measured the alternating component of plate current may be calibrated in terms of micrombos of transconductance instead of microamperes of alternating current."

Figure 1 is a block diagram of this tester.

For the purpose of giving qualitative information on the tests, it will be necessary to introduce the identification system used on the tubes. The tubes were assigned a two letter symbol followed by a number. The first letter designates the manufacturer - "S" denoting Manufacturer "S" and "R" denoting Manufacturer "R"; the second letter identifies the lot number - there being three lots of Manufacturer "S" Tubes designated "SA", "SB", and "SC", and four lots of Manufacturer "R" Tubes designated "RA", "RB", "RC", and "RD". Table I in Appendix I identifies the tubes by manufacturers' lot numbers.

In Tables II through VIII of Appendix I

BLOCK DIAGRAM MODEL OD TESTER

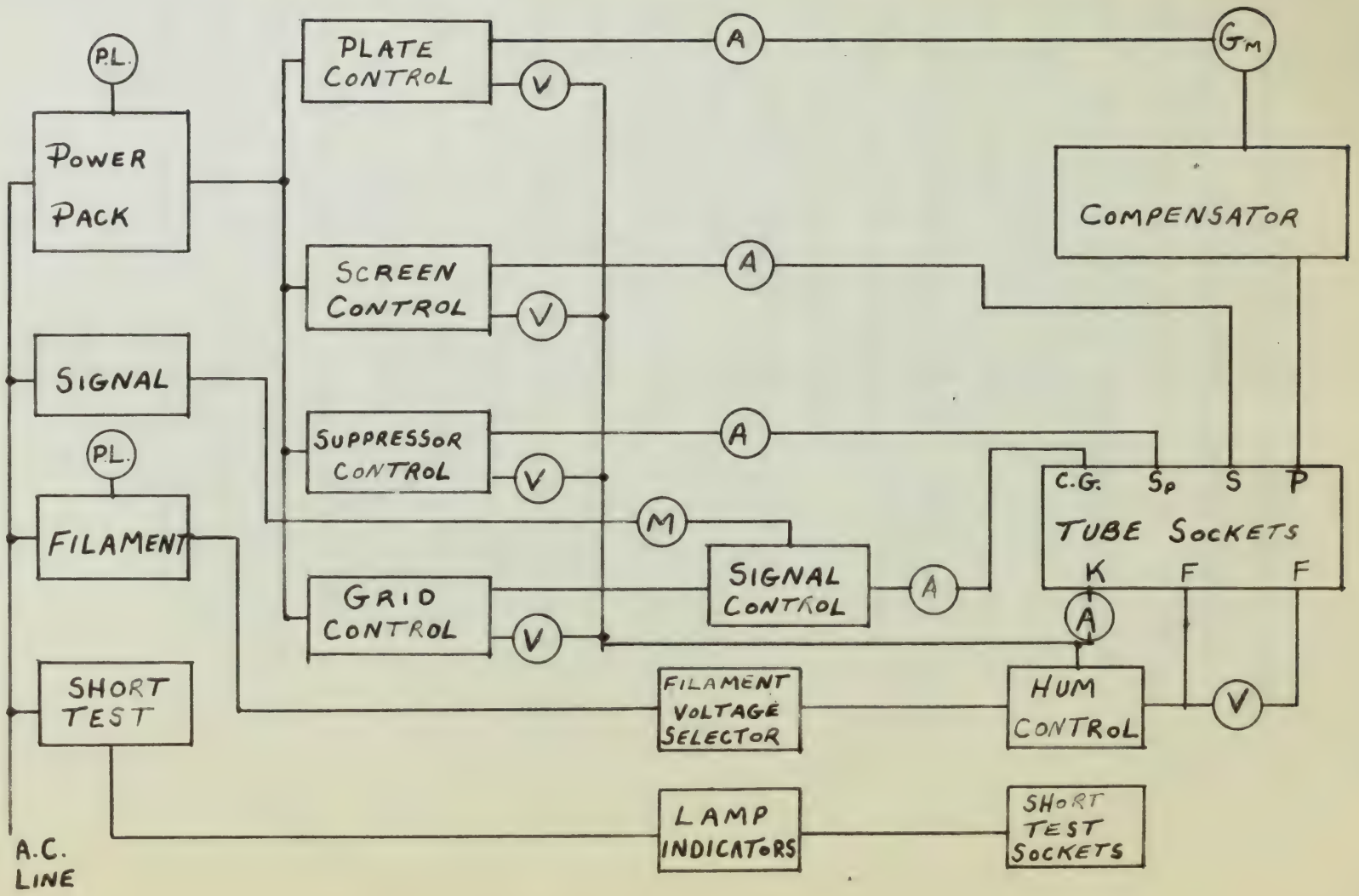


FIGURE 1

are tabulated values of Plate Current, Transconductance, and Plate Resistance for each tube for 100% Plate Voltage and Heater Voltage. Plate resistances were computed by the formula $\mu = \frac{\Delta E \text{ plate} \times 1000}{\Delta I \text{plate}}$ where ΔEplate was = 20 volts in each case (i. e. 100 to 80 volts for Manufacturer "S" Tubes and 120 to 100 volts for Manufacturer "R" Tubes). Iplate was in milliamperes.

While a value of ΔEplate of 20 volts may seem too large an increment to take in computing plate resistances, it will be seen from the Characteristic Curves (Plates I through VII) that the slope of the curves from 100 to 80 volts in the case of Manufacturer "S" Tubes, and from 120 to 100 volts in the case of Manufacturer "R" Tubes is substantially a constant value. This being the case the twenty volt increment became a reasonable one to take since it eliminated an extra voltage reading on each tube.

voltage reading on each tube.

The manufacturers give the following as "Typical Operating Conditions" for the Type 6K4-A and CK608CX Tubes:

Manufacturer "S" Type 6K4-A Tubes

Heater Voltage	6.3	6.3	Volts
Heater Current	150	150	Ma
Plate Voltage	100	200	Volts
Grid Bias Voltage	-2	-8	Volts
Plate Current	13.0	11.5	Ma
Amplification Factor	20	16	
Plate Resistance	3640	4650	Ohms
Grid Voltage for Plate current cut-off to 10 amp.	-14	-30	Volts
Transconductance	5500	3450	Micromhos

Manufacturer "R" Type CK608CX Tubes

Heater Voltage	6.3	Volts
Heater Current	200	Ma
Plate Voltage	120	Volts
Grid Bias Voltage	-2	Volts
Plate Current	9.0	Ma *
Transconductance	5000	Micromhos
Amplification Factor	25	

* Manufacturer's Curve Plots this as 8.3 Ma.

A comparison of the average values of I_{plate} and g_m with the Manufacturer's Typical Operating Values is given in the following table (r_p is not included here because Manufacturer "R" Tube Characteristic Sheet quotes no value of r_p).

	Manufacturers Typical I_p milliamps	Actual average I_p milliamps	Diff.
Manufacturer "S" Tubes	13.0	11.2	-1.8
	13.0	15.6	+2.6
	13.0	11.3	-1.7
Manufacturer "R" Tubes	9.0	11.7	+2.7
	9.0	11.0	+2.0
	9.0	9.0	0.0

	Manufac. Typical gm micromho	Actual average g micromho	Diff.
Manufacturer "S" Tubes	5500	3695	-1805
	5500	4320	-1180
	5500	3675	-1825
Manufacturer "R" Tubes	5000	4150	- 850
	5000	3980	-1010
	5000	3660	-1340

In the next table below the average variations from the mean values of Plate current, plate resistance, and transconductance are given:

	I_{plate}	r_p	g_m	Number good tubes in lot
Manufacturer "S" Tubes	1.77	470	312	34
	1.44	216.2	214.7	33
	1.56	408	292	31
			Total	98
Manufacturer "R" Tubes	.98	316	226.5	9
	1.01	444	215	26
	1.33	892	281	23

	I_{plate}	r_p	f_m	Number good tubes in lot
Manufacturer "R" Tubes	.72	266	195	40
		Total		98

Manufacturer "S" Tubes	number bad tubes in lot	% good tubes
	1	97.1
	2	94.3
	4	88.6
Total	7	

Manufacturer "R" Tubes		
	1	90
	0	100
	1	96
	0	100
Total	2	

It will be observed that of 105 "S" Tubes tested, 98 were good - percentage 93.4; while for 100 "R" Tubes tested, 98 were good - percentage 98.

Weighted value of average variation from mean value of I_{plate} is computed in Table IX of Appendix I.

Table IX of Appendix I.

	Plate B		
Temperature "2" Tubes	472	506	348
	Total		
Temperature "2" Tubes	Tubes in lot number per		% good tubes
	1		67.1
	8		96.8
Total	9		88.8
Temperature "3" Tubes	9		90
	8		100
	1		99
	0		100
Total	8		

It will be observed that of 108 "3" Tubes tested, 88 were good - percentage 81.4; while for 108 "2" Tubes tested, 88 were good - percentage 80.

Similar computations give the following weighted-in variations from mean value of g_m and r_p.

	Weighted var. of g_m	Weighted var. of r_p	Weighted var. of I_{plate}
Manufacturer "S" Tubes	272.5	320.5	1.591
Manufacturer "R" Tubes	223.0	501.0	.963

The results above lead to the conclusion that Manufacturer "R" CK6086X Tube is more uniform in static characteristics from tube to tube than is the Manufacturer "S" 6K4-A Tube. It is realized that the comparison given in the three tables above is not a measure of the relative merits of the tubes on an absolute basis. It does demonstrate clearly, however, that the manufacturers of the "S" tubes are apt to overrate their tubes more than the manufacturers of the "R" Tubes.

The tubes which were classified as bad

tubes showed the following faults on being tested:

Tubes SA-28, SB-19, SC-8 indicated no internal short circuits, but each drew large excess heater current at rated value of heater voltage.

Tubes SB-33, SC-12, RC-21 drew five percent or less of rated value of plate current at rated value of plate voltage.

Tube SC-15 indicated several internal short circuits, and drew large excess heater current at rated value of heater voltage.

Tube SC-29 drew approximately 50% excess heater current at rated value of heater voltage. The plate current was approximately two percent of rated value at rated value of plate voltage.

Tube RA-7 indicated an internal short circuit from the grid to the heater. It drew a large grid current when the grid bias voltage was applied.

voltage was applied.

Type 24-7 includes an internal short circuit from the grid to the heater. If grid bias voltage is applied to the heater, the full plate voltage flows.

Type 24-7 includes an internal short circuit from the grid to the heater. If grid bias voltage is applied to the heater, the full plate voltage flows.

Type 24-12 draw approximately 200 milliamperes current at rated value of plate voltage.

Type 24-12 draw approximately 200 milliamperes current at rated value of heater voltage. The plate current can approximately equal heater current at rated value of heater voltage.

Type 24-22 draw approximately 200 milliamperes current at rated value of heater voltage.

Types 24-23, 24-12, 24-23 draw five percent or less of rated value of plate current at rated value of plate voltage.

Types 24-23, 24-12, 24-23 draw five percent or less of rated value of plate current at rated value of plate voltage.

Types 24-23, 24-12, 24-23 draw five percent or less of rated value of plate current at rated value of plate voltage.

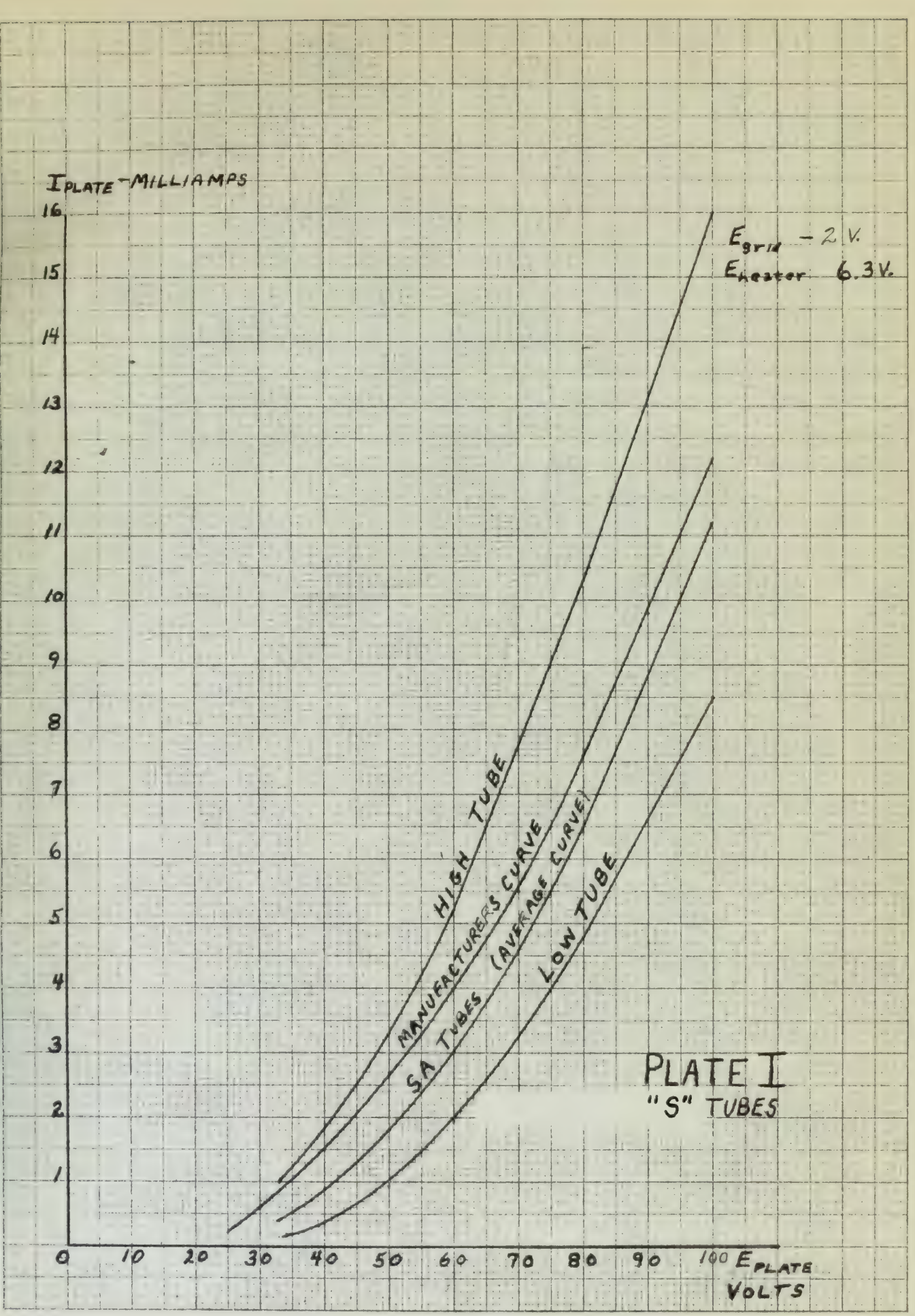
Type 24-12 indicated external internal short circuit, but does have plate current at rated value of plate voltage.

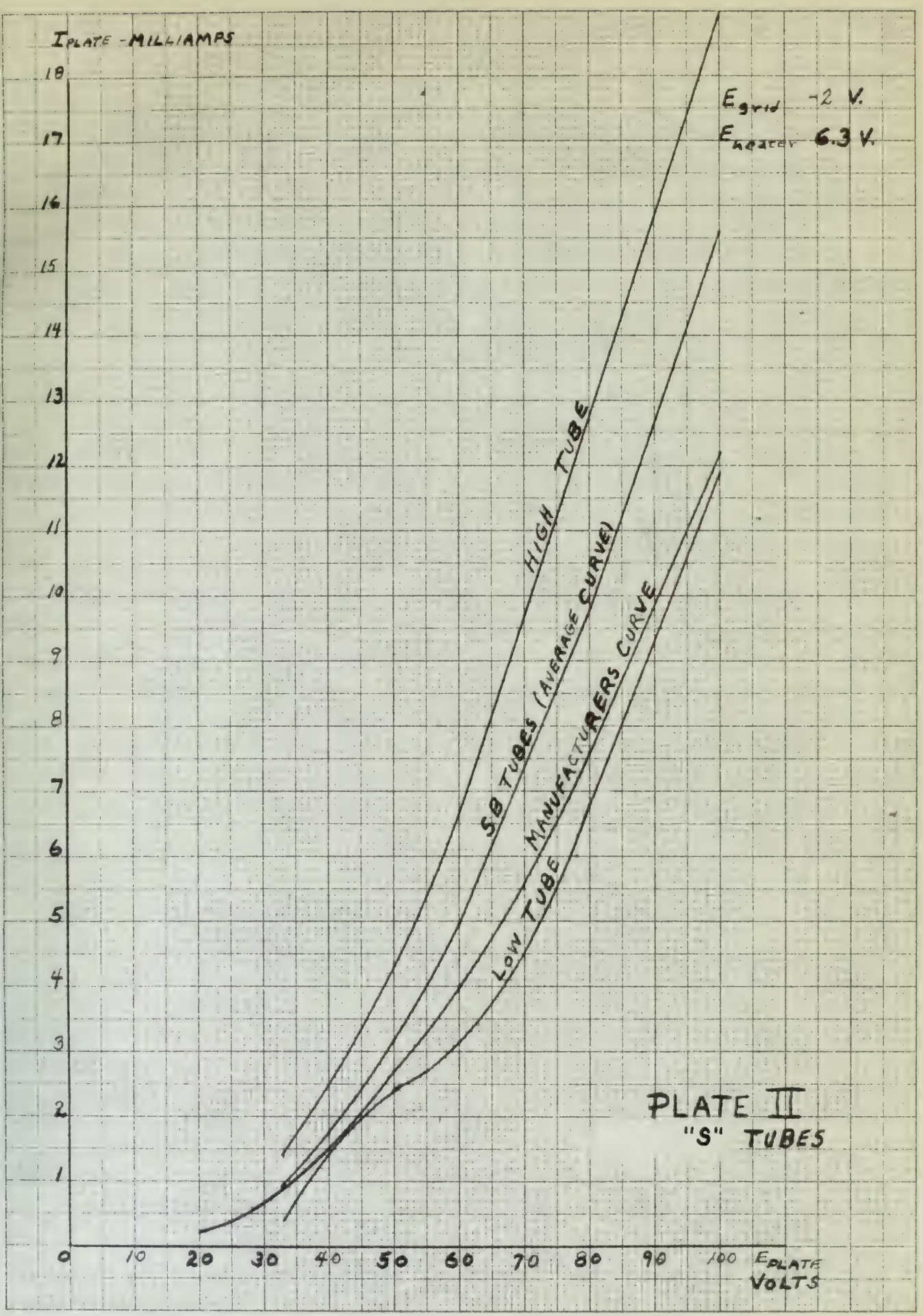
Type 24-12 indicated external internal short circuit, but does have plate current at rated value of plate voltage.

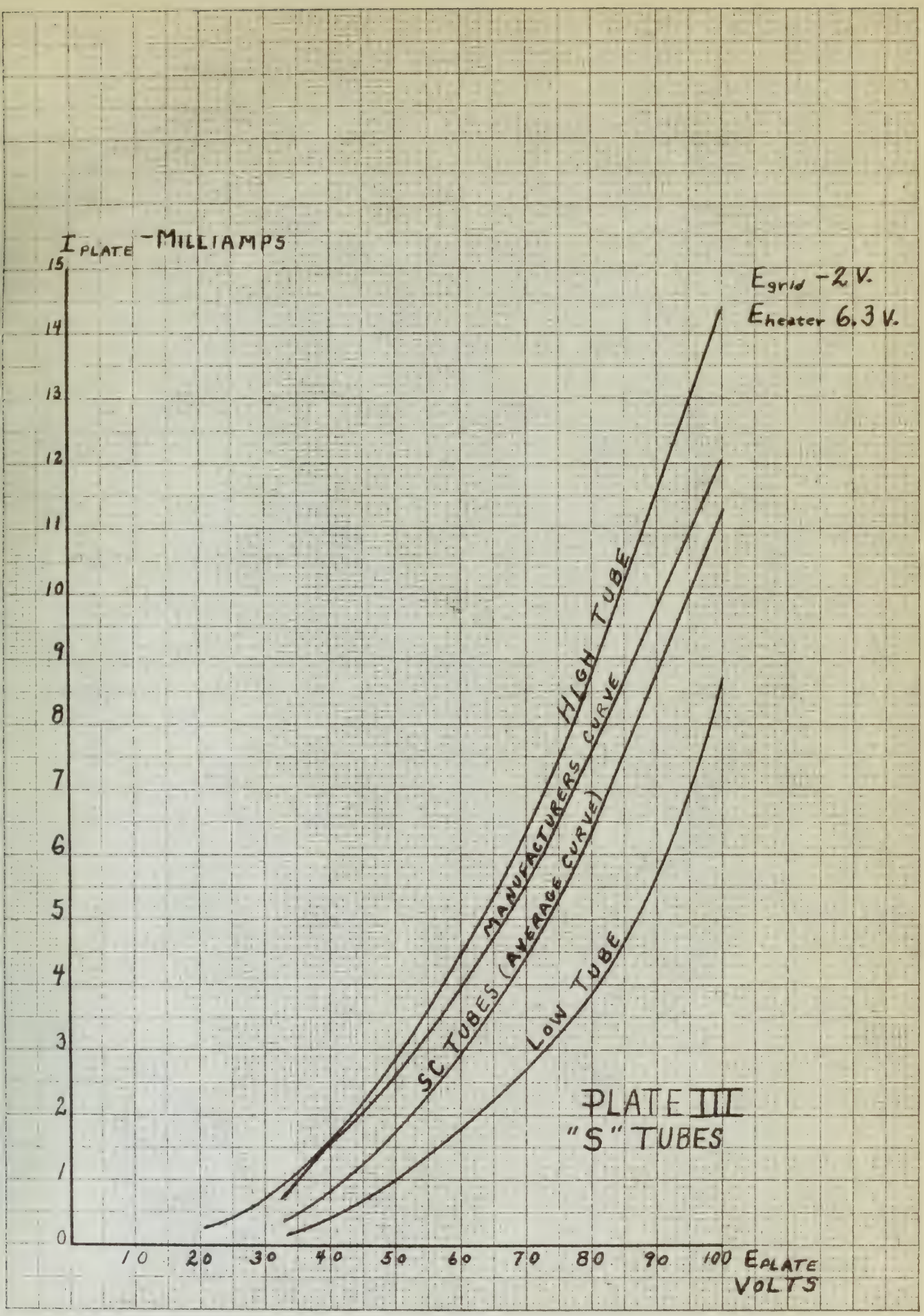
Type 24-12 indicated external internal short circuit, but does have plate current at rated value of plate

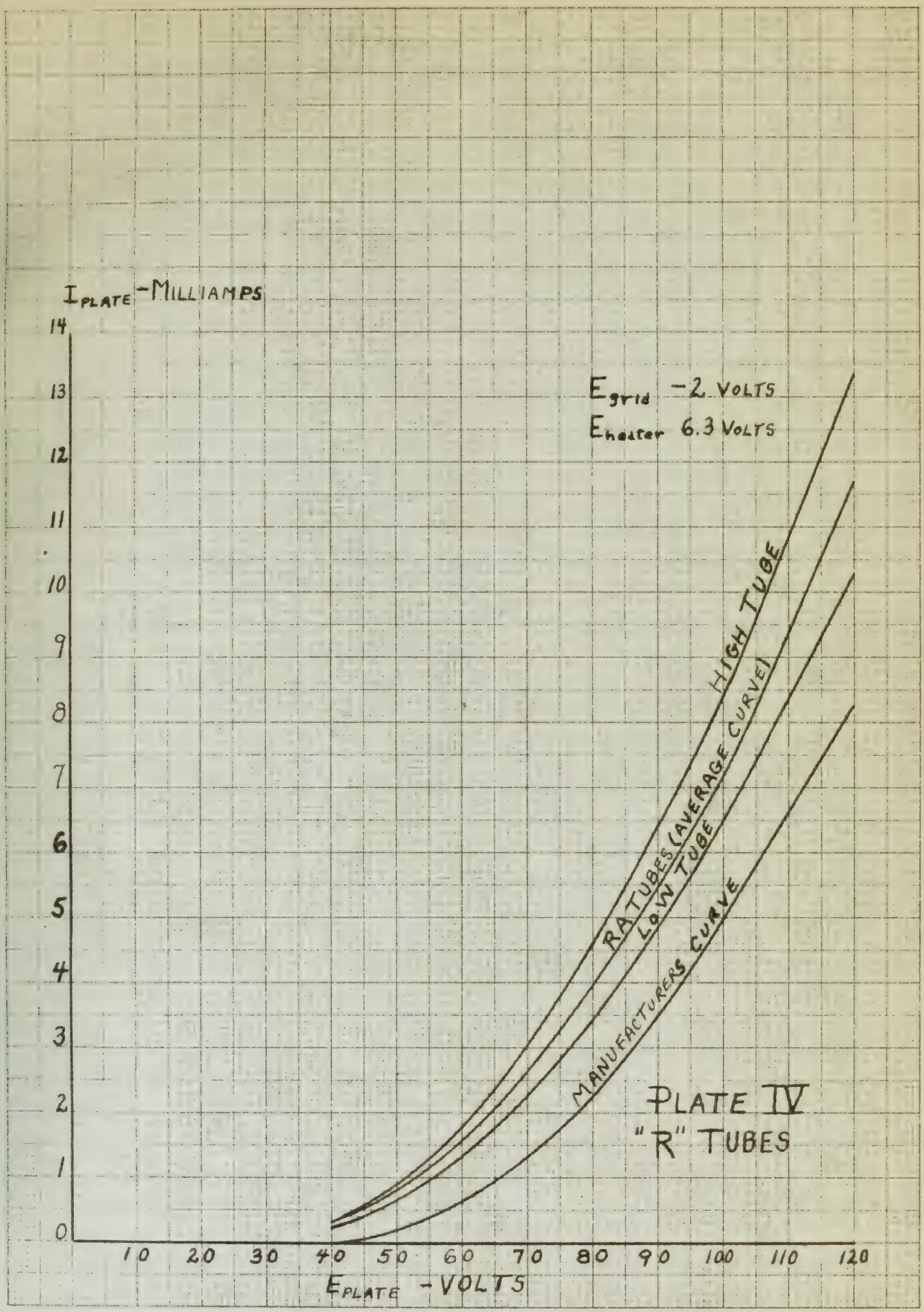
Comparison of Plate Characteristics of Manufacturer "S" and Manufacturer "R" Tubes

From the tests made on the OD Tester, it is possible to plot Plate Characteristic Curves for a grid bias of -2 volts. A plot of the average Plate Characteristic for each tube lot, the Manufacturers Plate Characteristic, and the characteristic of the high and low tube in each lot has been made on Plates I through VII which follow.


I PLATE - MILLIAMPS
16
15
14
13
12
11
10
9
8
7
6
5
4
3
2
1
0
10
20
30
40
50
60
70
80
90
100
E PLATE VOLTS
E grid - 2 V.
E Heater 6.3 V.
HIGH TUBE
MANUFACTURERS CURVE
SA TUBES (AVERAGE CURVE)
LOW TUBE
PLATE I
"S" TUBES


I PLATE - MILLIAMPS
18
17
16
15
14
13
12
11
10
9
8
7
6
5
4
3
2
1
0
10
20
30
40
50
60
70
80
90
100
E PLATE VOLTS
E grid -2 V.
E heater 6.3 V.
HIGH TUBE
58 TUBES (AVERAGE CURVE)
MANUFACTURERS CURVE
LOW TUBE
PLATE II
"S" TUBES


I PLATE - MILLIAMPS
15
14
13
12
11
10
9
8
7
6
5
4
3
2
1
0
E grid -2 V.
E heater 6.3 V.
HIGH TUBE
MANUFACTURERS CURVE
SC TUBES (AVERAGE CURVE)
LOW TUBE
PLATE III
"S" TUBES
10
20
30
40
50
60
70
80
90
100
E PLATE
VOLTS


I PLATE - MILLIAMPS
14
13
12
11
10
9
8
7
6
5
4
3
2
1
0
E grid -2 VOLTS
E heater 6.3 VOLTS
HIGH TUBE
RA TUBES (AVERAGE CURVE)
LOW TUBE
MANUFACTURERS CURVE
PLATE IV
"R" TUBES
10 20 30 40 50 60 70 80 90 100 110 120
E PLATE - VOLTS

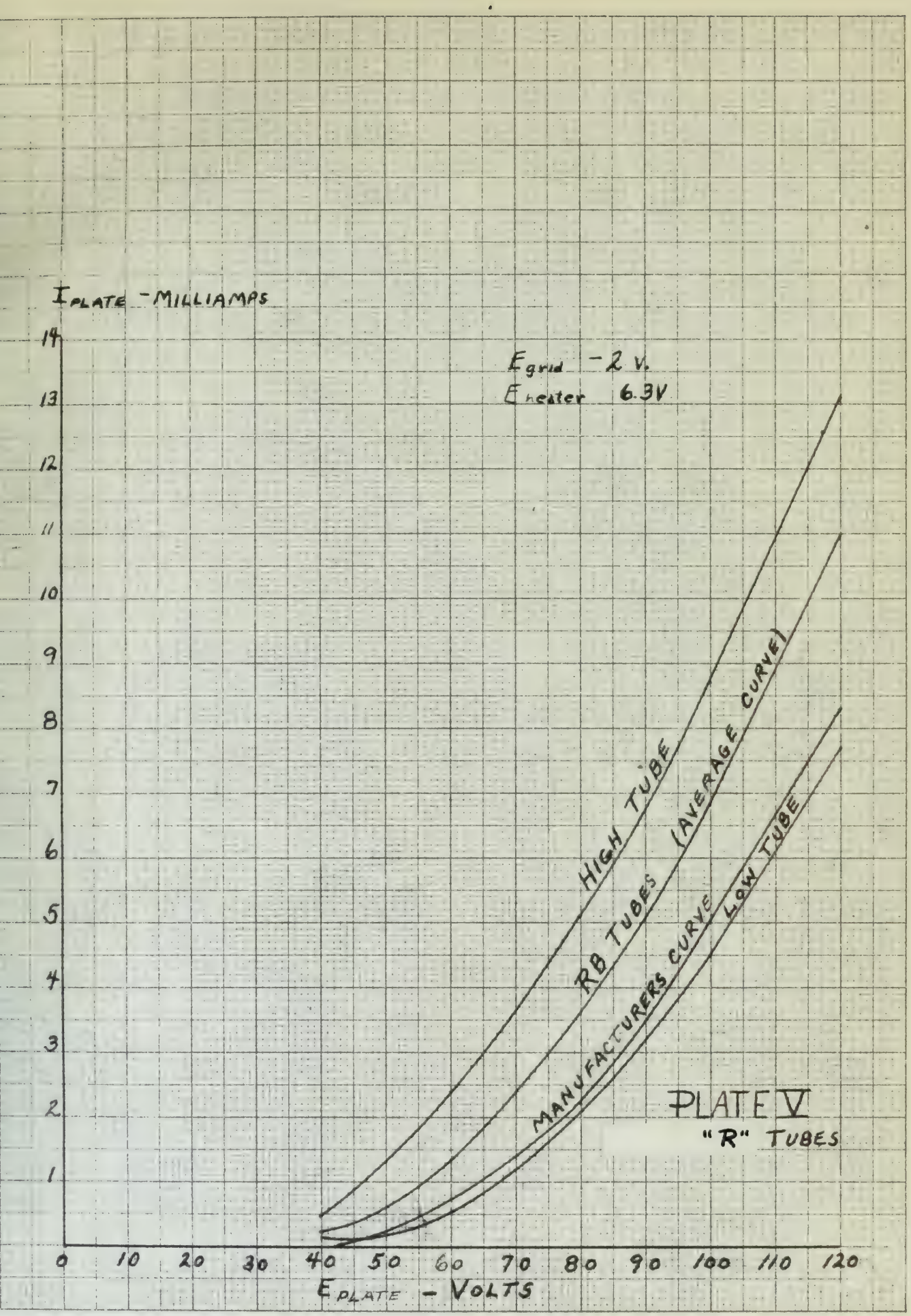
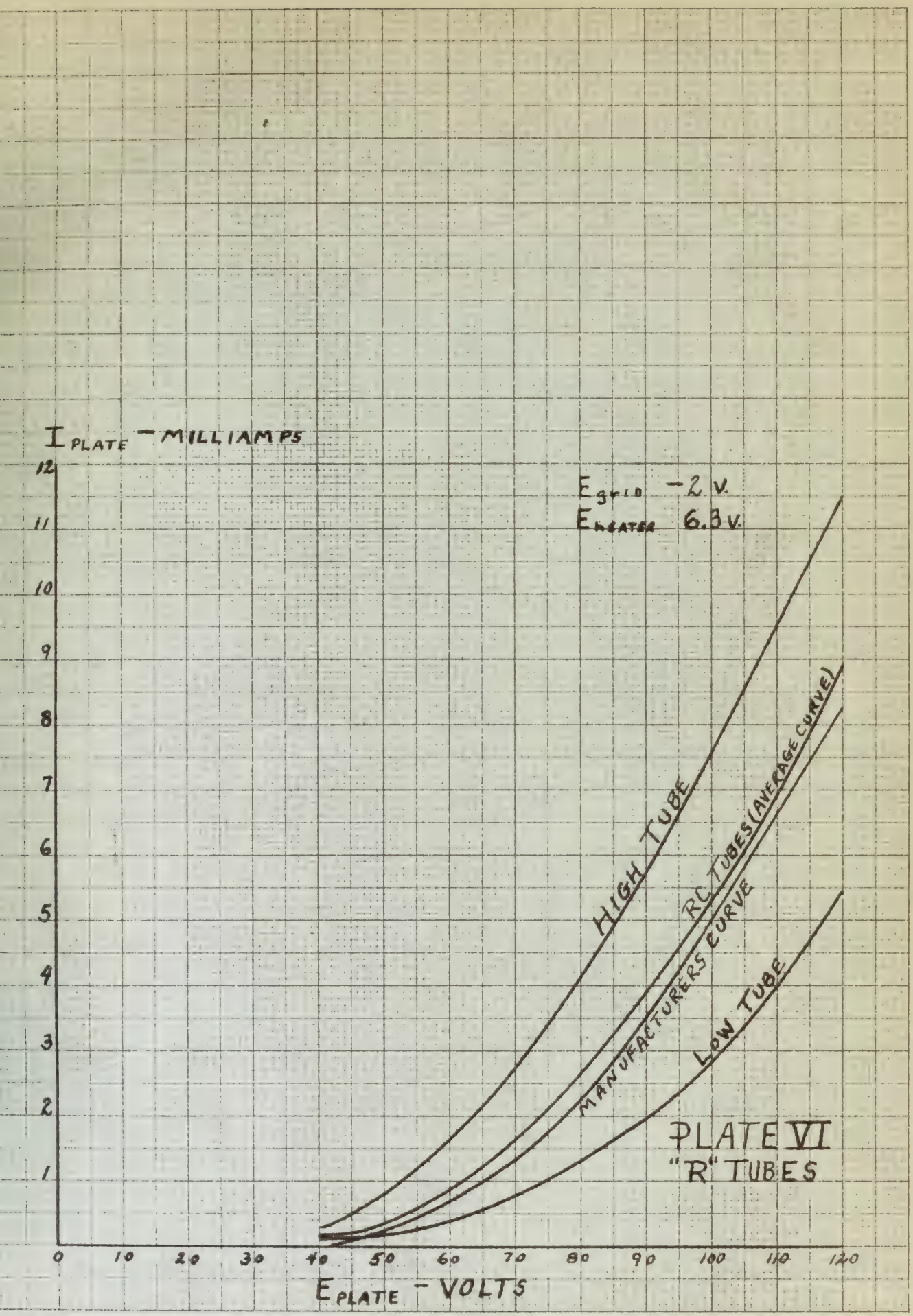
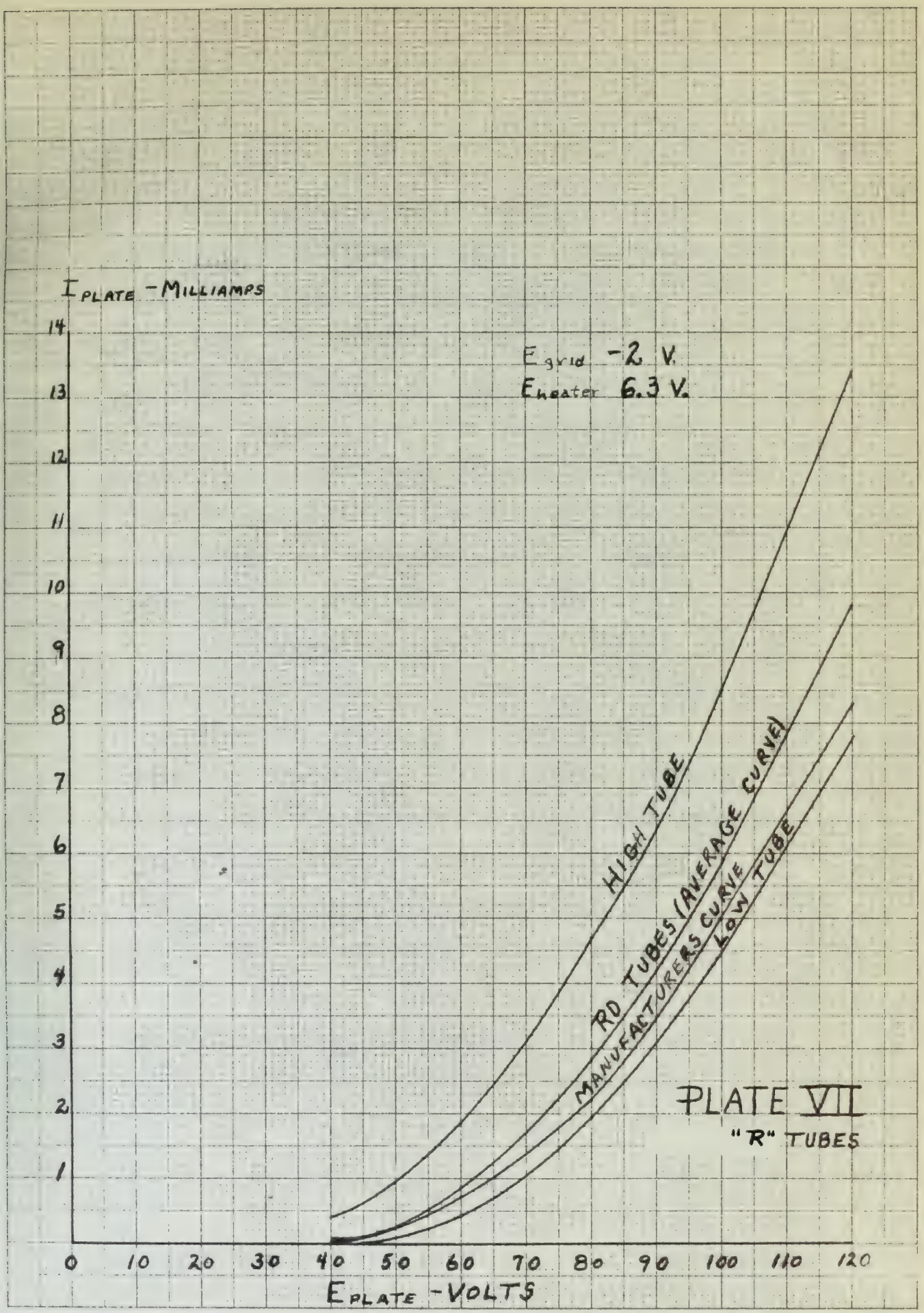


PLATE V

"R" TUBES


I PLATE - MILLIAMPS
12
11
10
9
8
7
6
5
4
3
2
1
E grid -2 V.
E heater 6.3 V.
HIGH TUBE
RC TUBES (AVERAGE CURVE)
MANUFACTURERS CURVE
LOW TUBE
PLATE VI
"R" TUBES
0
10
20
30
40
50
60
70
80
90
100
110
120
E PLATE - VOLTS


I PLATE - MILLIAMPS
14
13
12
11
10
9
8
7
6
5
4
3
2
1
E grid -2 V.
E heater 6.3 V.
HIGH TUBE
RD TUBES (AVERAGE CURVE)
MANUFACTURERS CURVE
LOW TUBE
PLATE VII
"R" TUBES
0
10
20
30
40
50
60
70
80
90
100
110
120
E PLATE - VOLTS

Examination of the curves in Plates I through VII shows two important points about the tubes. First, the average characteristic curve for the Manufacturer "R" Tubes is in each case higher than the Manufacturers Curve. In the case of the Manufacturer "S" Tubes in two cases out of three, it is lower than the manufacturer's curve. Secondly, the spread between high and low tube in a lot is greatest for Manufacturer "S" Tubes Lot SA.

One interesting point in connection with the static tests was the appearance in some tubes of small grid currents of the order of 100 to 700 microamps when heater voltage was set at 6.3 volts and no grid bias nor plate supply voltage was applied. This grid current was present in approximately 40% of the tubes of each manufacture. The tubes in which this grid current appeared tested in general above the average values of plate current and transconductance. For example in one lot this grid current appeared in 10

of 35 tubes. The average I_{plate} for these 10 tubes was 12.9 m.a. compared with an average value of 11.3 m.a. for the entire lot. The average g_m for these same 10 tubes was 4130 micromhos compared to 3675 micromhos for the entire lot.

Tubes in which the grid current appears probably have cathodes of better emission characteristics than those of the tubes in which this current does not appear.

CHAPTER III

DESCRIPTION OF DYNAMIC TESTS

The dynamic tests were made to simulate the performance of an amplifier tube in a very high frequency F-M transmitter. A circuit diagram of the transmitter if given as Figure 2. Specifications for the transmitter are as follows:

R.F. Output Impedance	51.5 ohms
Tuning Range	209 mc to 227 mc.
Nominal Power Output	0.5 watt

Typical Operation:

Plate Supply Voltage	150 V.D.C.	115 V.D.C.
Plate Current	45 ma	35 ma
Heater Current	0.45 amp.	0.45 amp.
Power Output (51.5 ohm)	0.5 watt	0.5 watt

To reproduce exactly the conditions which exist in the amplifier of this transmitter, it would be necessary to build the complete unit according to specifications taking necessary precautions to shield the

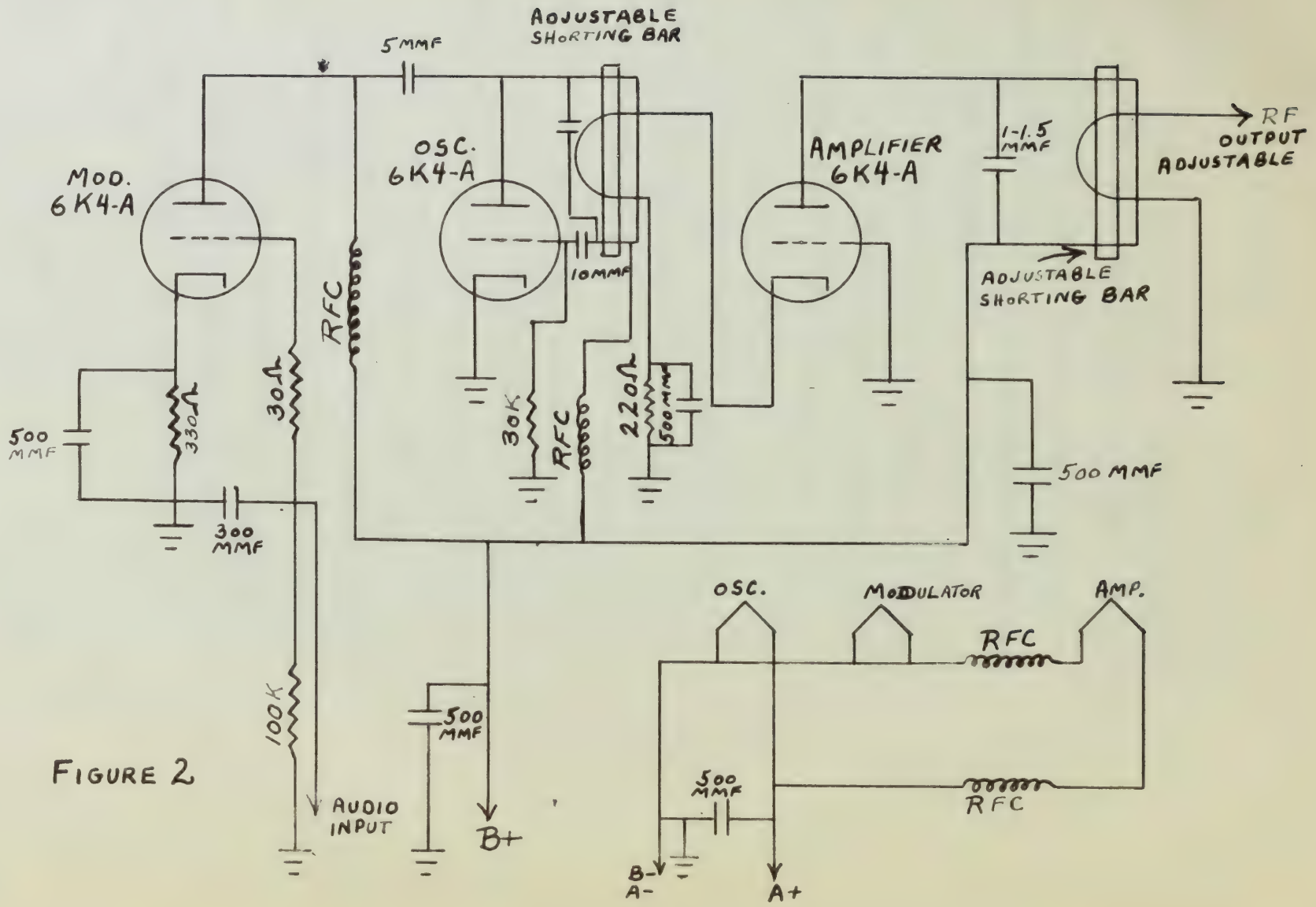

ADJUSTABLE SHORTING BAR
5MMF
MOD. 6K4-A
OSC. 6K4-A
AMPLIFIER 6K4-A
1-1.5 MMF
RF OUTPUT ADJUSTABLE
ADJUSTABLE SHORTING BAR
10MMF
RFC
500 MMF
330Ω
30Ω
300 MMF
30K
RFC
220Ω
500 MMF
500 MMF
100K
AUDIO INPUT
500 MMF
B+
OSC.
MODULATOR
AMP.
RFC
500 MMF
RFC
B-
A-
A+

FIGURE 2

various stages, use leads to tubes as short as possible, and observe strictly all ordinary precautions to eliminate stray capacitances. This procedure would permit the testing of only one amplifier tube at a time. It would also be necessary to solder the leads of each tube in place for test, as there are no base pins or tube sockets for this type tube.

In view of the above stated conditions, and because it was desired to run normal load and particularly overload tests on as many tubes as possible, a simulator circuit using low frequency input was decided upon. The advantages of such a circuit from the testing point of view are many: a) Use of shielding in the chassis is not necessary. b) Several tubes can be tested simultaneously. c) Tubes can be mounted in tube socket adapters which are easily removable and in which tubes can be quickly inserted without soldering.

The simulator circuit used is believed to be as close an approximation to the actual circuit as can be had using low frequency. The power outputs of the tubes in the simulator circuit can be adjusted to values reasonably close to the output obtained on test of the transmitter, depending on the uniformity of the ten tubes being tested.

Admittedly the simulator circuit is an alternative method of testing because it is generally accepted that the only real test of how a particular tube will perform in a particular circuit is its performance in that circuit. When the time requirements for testing in the actual circuit are considered, however, it is apparent that if more than a "handful" of tubes are to be tested singly an enormous amount of time would be required. The nine twenty hour tests described below would have required 1800 hours running time had the tubes been tested singly.

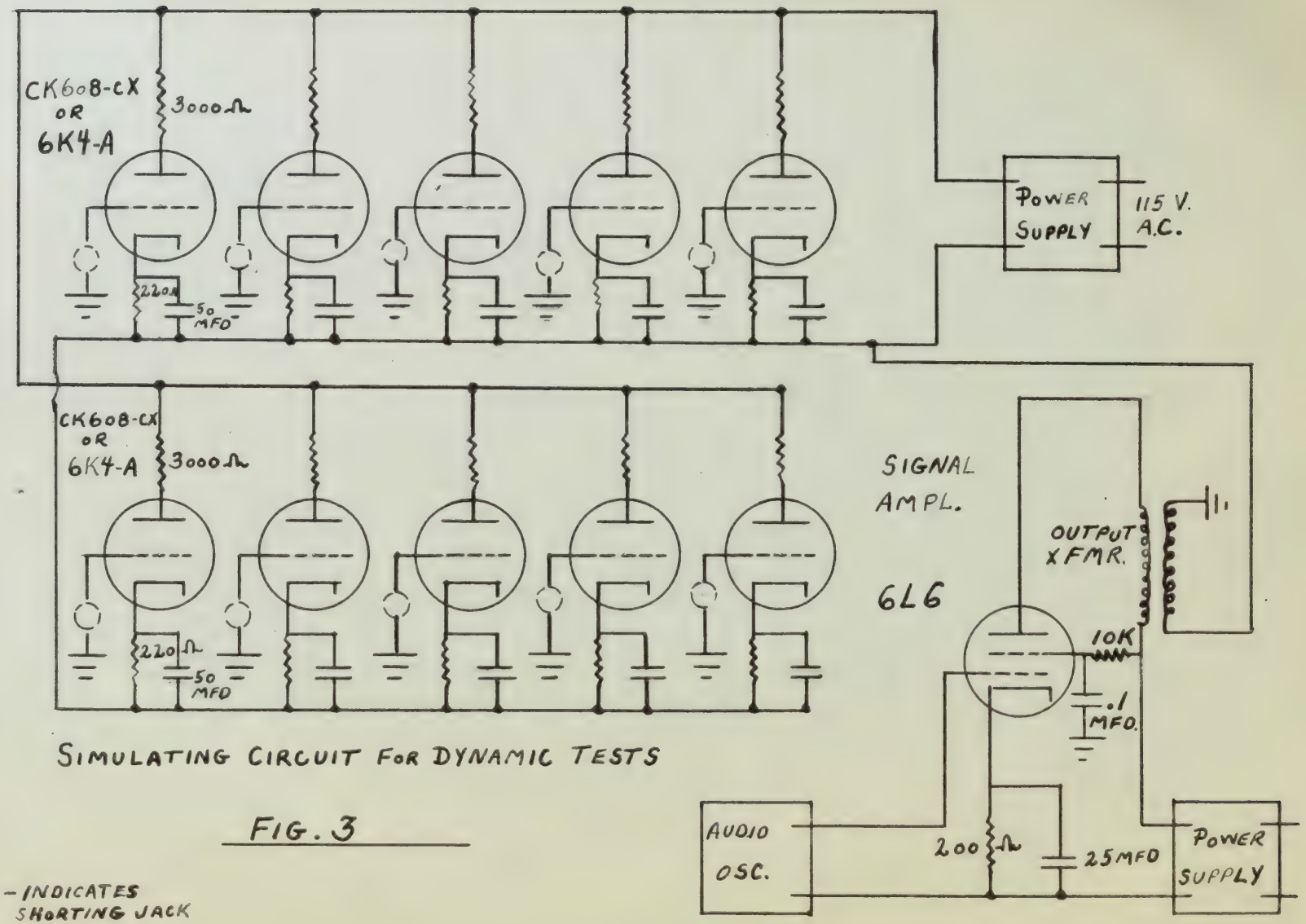
The circuit used to simulate the operation of the amplifier in the VHF Transmitter is shown in Figure 3. Originally a signal input frequency of 60 cycles per second was to be used. The impedance of the test circuit was so low, however, that a capacitor of approximately 100 mfd. would have been required across the power supply output to make the impedance of this capacitor small compared to the test circuit impedance. A signal frequency of 1000 cycles per second was therefore used, which was amplified before being applied to the test circuit.

As will be seen from the circuit diagram, the ten tubes to be tested were connected in parallel as separate amplifier tubes using common plate supply voltage and input signal sources. The cathode resistors were made 220 ohms, the same value used in the original circuit. The by-pass capacitors across the cathode resistors were made 50 mfd. to assure adequate by-passing of alter-

nating current at low frequency. The value of the load resistors was chosen as 3000 ohms to be of the same order of magnitude as the plate resistance of the tubes, which is listed as 3640 ohms for the 6K4-A Tube at 100 volts plate voltage and -2 volts grid bias.

It will be seen from the circuit diagram that the cathodes of the tubes being tested were not grounded, but were connected to the minus side of the plate power supply. The signal voltage at 1000 cycles per second was applied at the same point as the minus side of the power supply. This connection makes the minus side of the power supply above ground potential by the amount of the signal voltage; but in view of the small value of signal voltage used (6.2 volts r.m.s. maximum), this is of no consequence.

The first tests were of twenty hours duration. Twenty hours intermittent operation was



SIMULATING CIRCUIT FOR DYNAMIC TESTS

FIG. 3

( ) - INDICATES SHORTING JACK

considered, by Applied Physics Laboratory, to be satisfactory life for the transmitter in which the tubes are used.

Measurements were made in the following manner: a) Plate supply voltage was measured by a voltmeter on the power supply which was corrected by comparison with the reading of a Weston 1000 ohms per volt laboratory type meter placed across the output terminals of the power supply. b) Total plate current was measured by a D.C. milliammeter in the output circuit of the plate power supply. c) Grid current was measured by a D.C. milliammeter of 0 - 10 m.a. range which was placed in the grid circuit of each tube successively by means of a phone plug inserted in a shorting jack. This meter was shunted by a 5 mfd. capacitor. d) Output power was measured by means of Cathode Ray Oscillograph. The vertical deflection plates of the oscilloscope were connected directly from the positive side of the plate power supply to

the plate of the tube whose power was being measured. This connection gave a trace on the oscilloscope of the voltage existing across the load resistor of the tube. This voltage trace was plotted on cross section paper and from the plot the power was calculated. A sample plot is given as Plate VIII and a sample power calculation from this plot is given in Table XI of Appendix I.

Plates VIII - A, and VIII - B are plots of the grid and plate voltage traces of the Manufacturer "S" and Manufacturer "R" Tubes respectively. These plots were made for the same plate supply and signal voltages on each tube. They represent typical operation of the tubes in the simulator.

Plate VIII - C is a plot of grid bias voltage versus plate current for tubes SR-27 and ER-12 at E_{plate} = 127, 100, 60 volts. The dynamic operation lines for each tube are drawn on this plot for conditions of operation shown in Plates VIII A and B.

shown in Plates XXII A and B.

drawn on it: plot for conditions of operation.

the dynamic characteristic lines for each tube are

and $R_{plate} = 10^{5}$, 100, 50 volts.

various values were used for these three

Plate XXII - C is a plot of grid bias

the tube in the simulator.

tube. They represent highest operation at

tube plate supply and signal voltages on this

respectively. These plots were made for the

temperature "A" and temperature "B" being

of the grid and plate voltage knobs of the

Plates XXII - A and XXII - B are plots

given in Table XI of Appendix I.

example linear calculations from this sine is

sample plot is given as Plate XXII and a

from the plot the power was calculated.

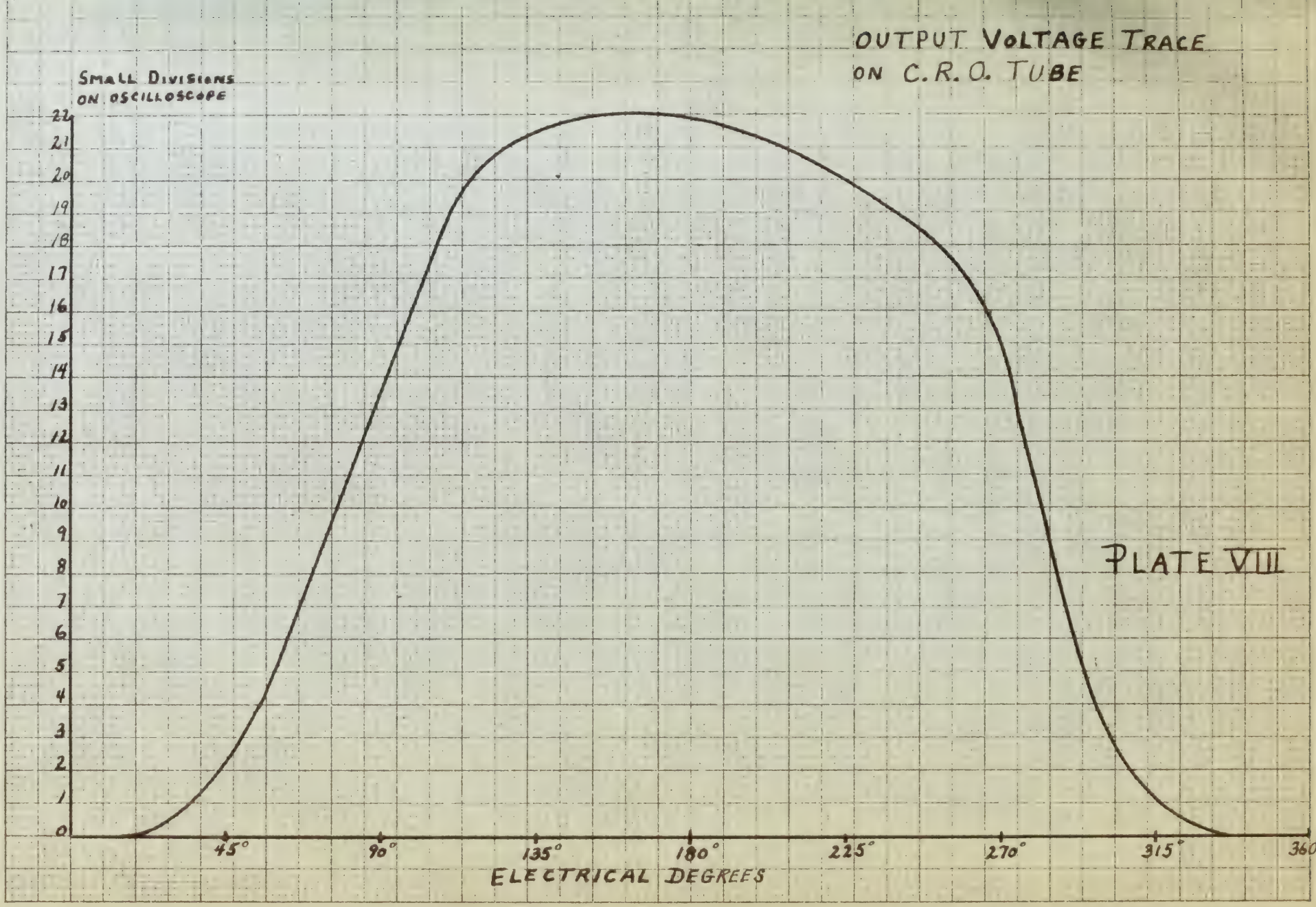
Plate were plotted on cross section paper and

the load resistor of the tube. This ampere-

the oscilloscope of the voltage existing across

measured. This connection read a trace on

the plate of the tube whose power output


OUTPUT VOLTAGE TRACE
ON C.R.O. TUBE
SMALL DIVISIONS
ON OSCILLOSCOPE
22
21
20
19
18
17
16
15
14
13
12
11
10
9
8
7
6
5
4
3
2
1
0
45°
90°
135°
180°
225°
270°
315°
360°
ELECTRICAL DEGREES
PLATE VIII

Plates VIII D and E are predicted plate voltage curves using the dynamic characteristics of Plate VIII C and the grid voltage curves of Plates VIII A and B. The actual curves obtained are plotted on the same sheet. Dashed portions of each curve are the extrapolated portions. The large difference between the curves at low values of plate voltage is caused by the fact that the grid is positive in this region and no data is available from curves of Plate VIII C on plate current for positive grid voltage.

The oscilloscope calibration of 4.9 volts per small scale division (49 volts per inch deflection) was obtained in the following manner: a) A D.C. voltage of known value was placed directly on the vertical deflection plates of the oscilloscope, (Dumont Type 208-P Cathode Ray Oscillograph). The deflection was found to be 10 small divisions (1 inch) per 49 volts D.C. b) An A.C. Voltage from an audio oscillator which

Plates VIII D and E are predicted plate voltage curves using the dynamic characteristics of Plate VIII C and the grid voltage curves of Plates VIII A and B. The actual curves obtained are plotted on the same sheet. Dashed portions of each curve are the extrapolated portions. The large differences between the curves at low values of plate voltage is caused by the fact that the grid is positive in this region and no data is available from curves of Plate VIII C on plate current for positive grid voltage.

The oscilloscope calibration of d.c. volts per small scale division (40 volts per inch deflection) was obtained in the following manner: a) A D.C. voltage of known value was placed directly on the vertical deflection plates of the oscilloscope. (Dumont Type 208-B Cathode Ray Oscillograph). The deflection was found to be 10 small divisions (1 inch) per 40 volts D.C. b) An A.C. Voltage from an audio oscillator which

measured 15 volts r.m.s. was placed on the vertical deflection plates after the D.C. signal was removed. The deflection for this signal was 9 small divisions peak to peak, or 4.5 divisions peak value. Peak value of 15 volt r.m.s. signal = $15 \times \sqrt{2} = 21.2$ volts

$\frac{21.2 \text{ volts}}{4.5 \text{ divisions}} = 4.7$ volts/division

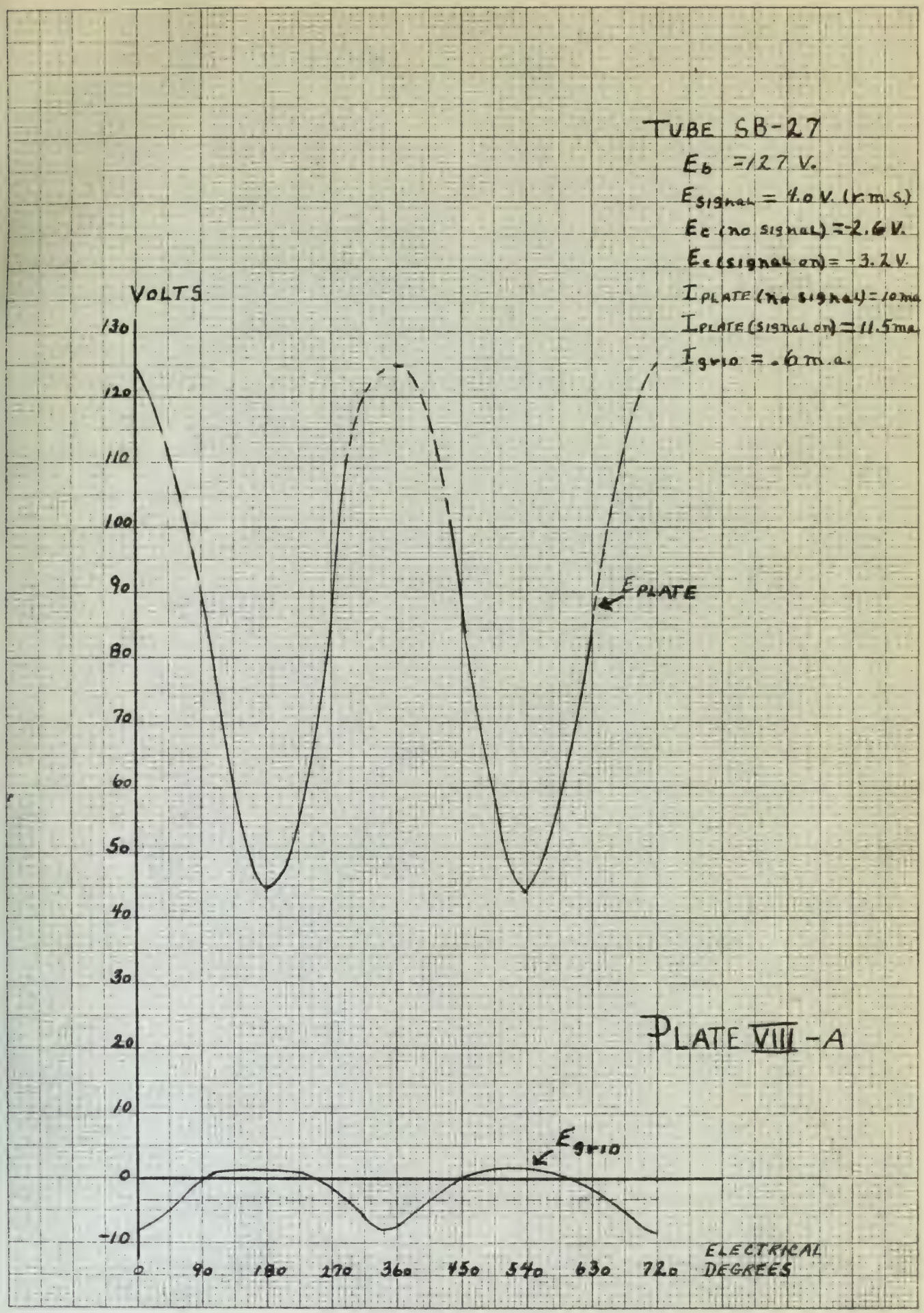
It was decided that 4.9 volts / division was a sufficiently accurate value and this value was used.

Actual Procedure Used for Tests

The procedure of testing in the simulating circuit shown in Figure 3 was as follows:

a) Ten tubes were tested simultaneously (unless there were not ten good tubes in one lot).

b) Plate supply voltage was adjusted whenever it was observed to have drifted from the desired value for the particular test. The plate voltage used for each test was determined by the "cut and try" method to obtain the power output desired with a reasonable value of signal voltage applied. The power output


TUBE SB-27
E_b = 127 V.
E_{signal} = 41.0 V. (r.m.s.)
E_c (no signal) = -2.6 V.
E_c (signal on) = -3.2 V.
I_{PLATE} (no signal) = 10 ma.
I_{PLATE} (signal on) = 11.5 ma.
I_{grid} = .6 m.a.
VOLTS
130
120
110
100
90
80
70
60
50
40
30
20
10
0
-10
E_{PLATE}
E_{grid}
0
90
180
270
360
450
540
630
720
ELECTRICAL DEGREES
PLATE VIII-A

TUBE RB-12

E_b = 127 V.

E_{signal} = 4.0 V. (r.m.s.)

$E_{grid\ (no\ signal)}$ = -1.84 V.

$E_{grid\ (signal\ on)}$ = -2.2 V.

$I_{PLATE\ (no\ signal)}$ = 7.5 m.a.

$I_{PLATE\ (signal\ on)}$ = 9.5 m.a.

I_{grid} = 0.72 m.a.

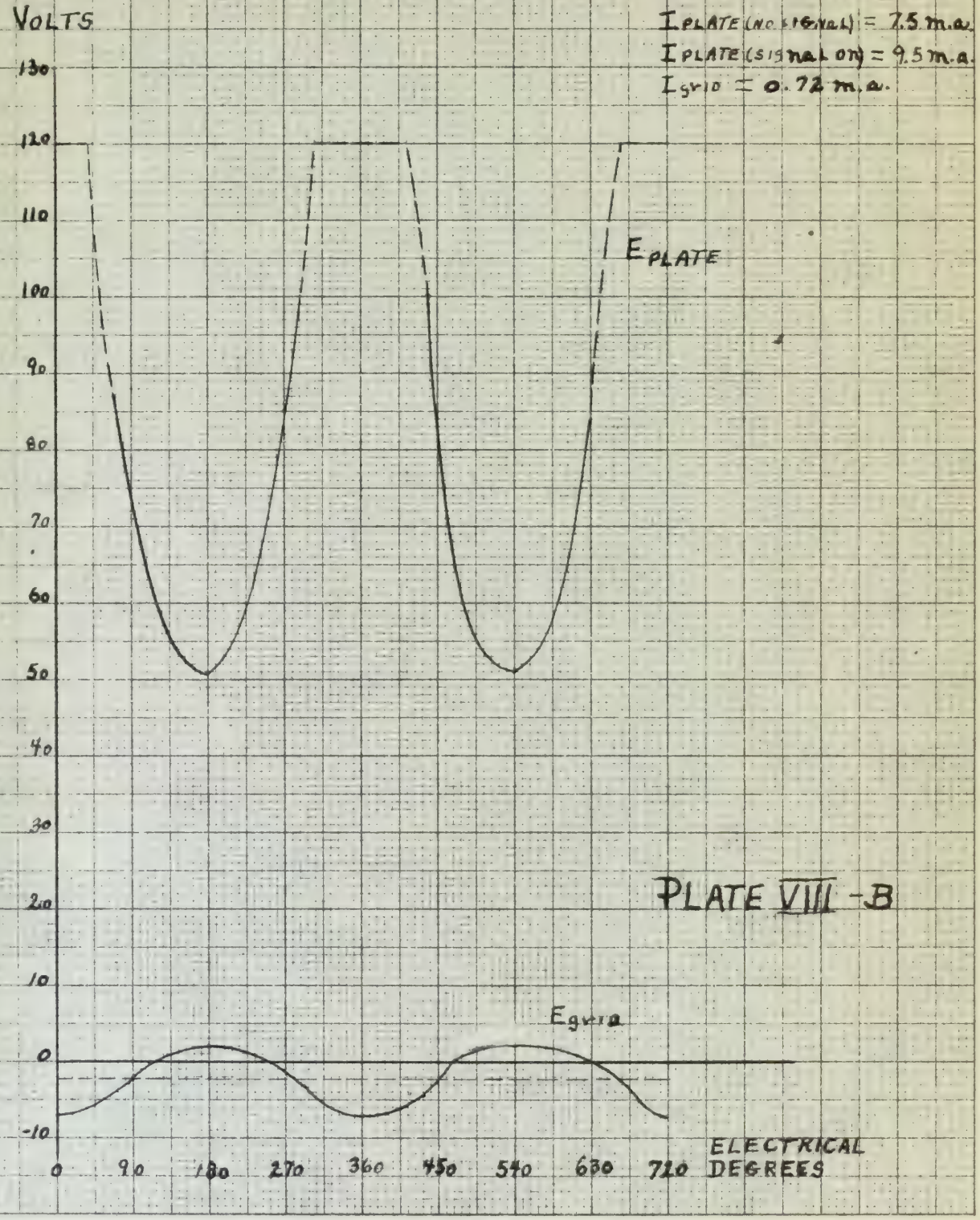
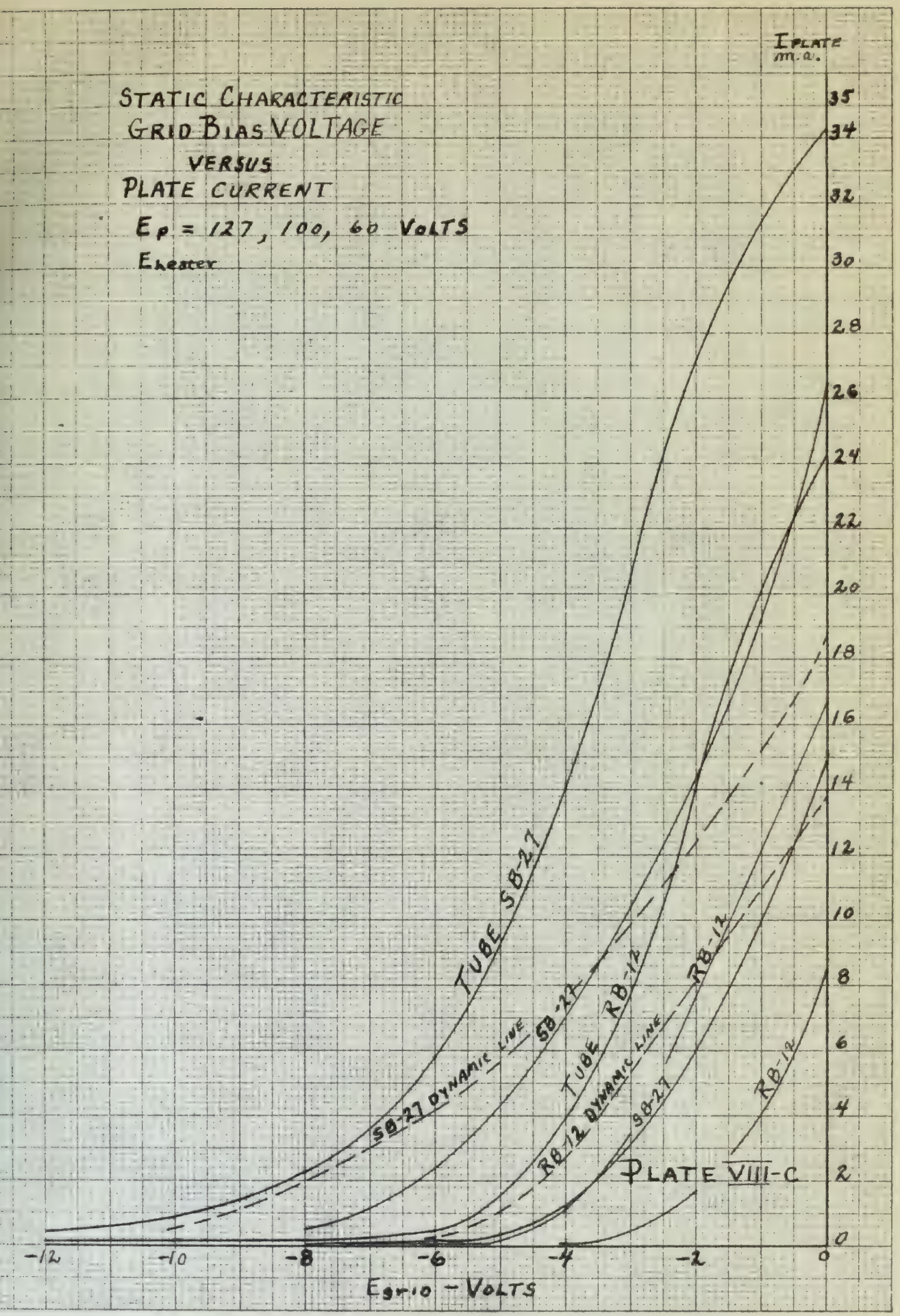


PLATE VIII-B


STATIC CHARACTERISTIC
GRID BIAS VOLTAGE
VERSUS
PLATE CURRENT
E_p = 127, 100, 60 VOLTS
Eheater
IPLATE m.a.
35
34
32
30
28
26
24
22
20
18
16
14
12
10
8
6
4
2
0
TUBE SB-27
SB-27 DYNAMIC LINE
SB-27
TUBE RB-12
RB-12 DYNAMIC LINE
RB-12
SB-27
RB-12
PLATE VIII-C
-12
-10
-8
-6
-4
-2
0
EGRID - VOLTS

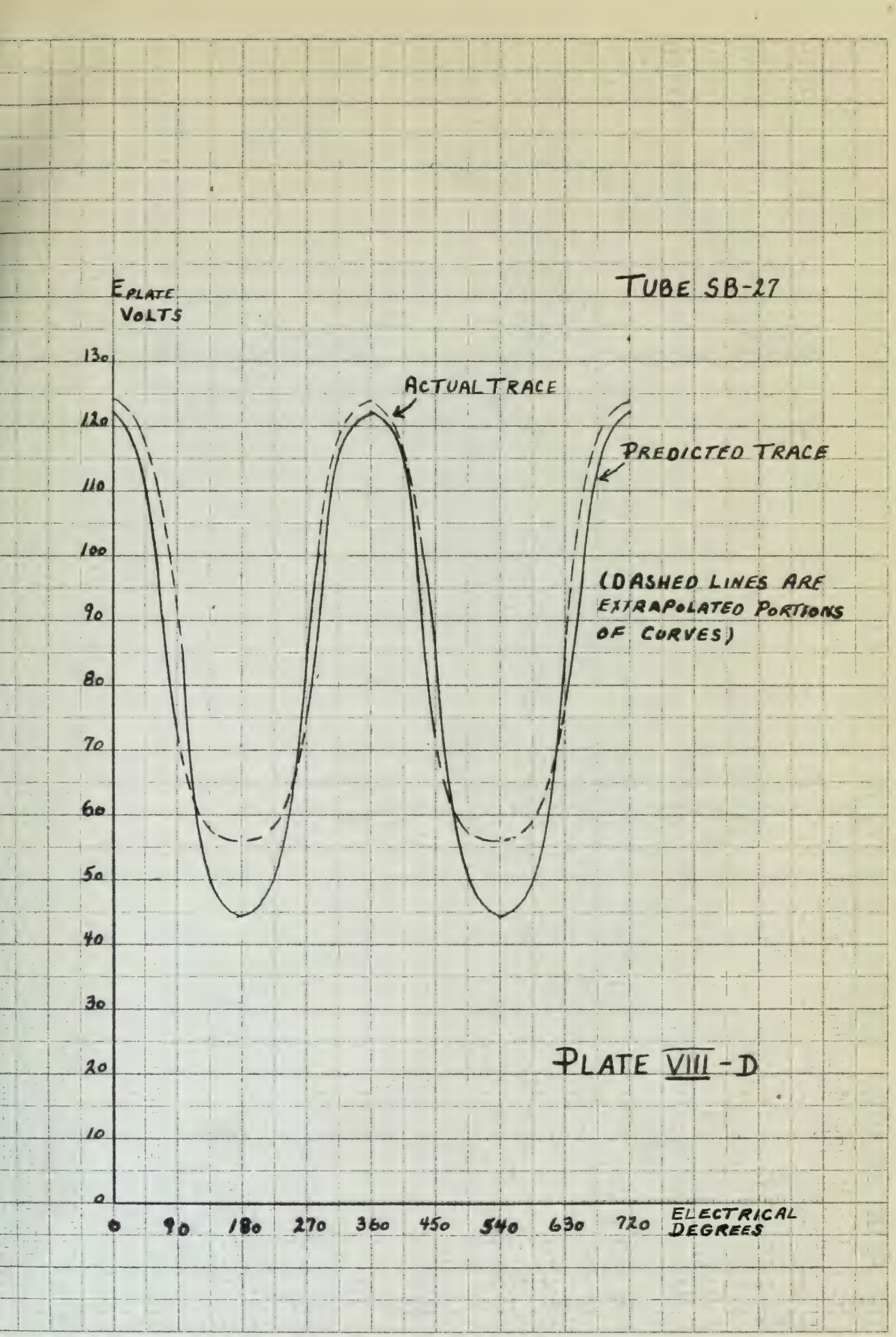
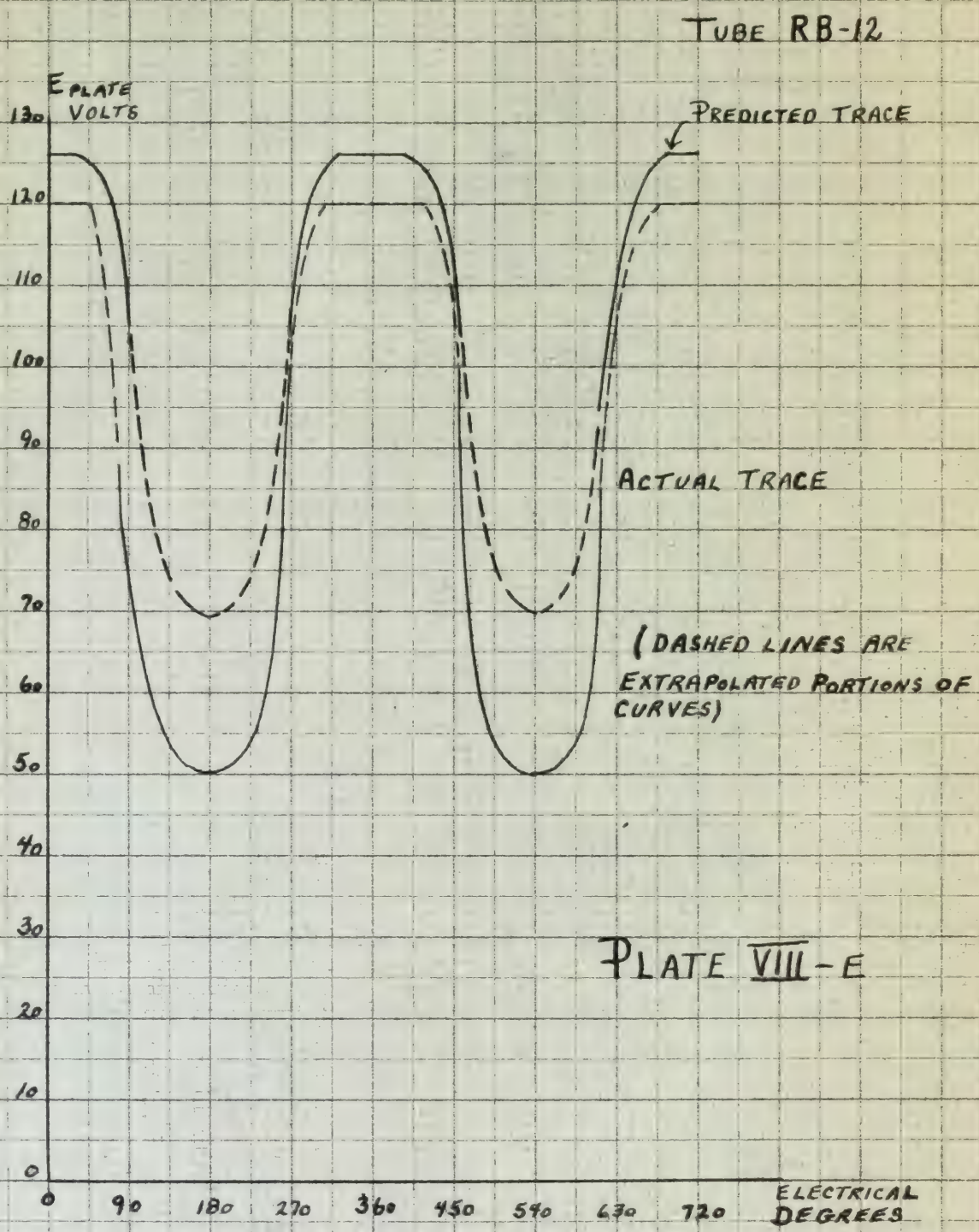

TUBE SB-27
E PLATE VOLTS
130
120
110
100
90
80
70
60
50
40
30
20
10
0
ACTUAL TRACE
PREDICTED TRACE
(DASHED LINES ARE EXTRAPOLATED PORTIONS OF CURVES)
0
90
180
270
360
450
540
630
720
ELECTRICAL DEGREES

PLATE VIII - D


TUBE RB-12
E PLATE VOLTS
130
120
110
100
90
80
70
60
50
40
30
20
10
0
PREDICTED TRACE
ACTUAL TRACE
(DASHED LINES ARE EXTRAPOLATED PORTIONS OF CURVES)
0
90
180
270
360
450
540
630
720
ELECTRICAL DEGREES
PLATE VIII-E

was computed from direct observation of the output voltage wave shape on the oscilloscope, as previously mentioned. Since the wave shape was made up of plate and signal voltage components essentially, and since a grid current not in excess of 5 m.a. per tube was desired, it was not difficult to obtain a combination of signal and plate voltage which gave the desired power output. On the first test run with Manufacturer "S" Tubes the plate supply voltage was set at 130 V. because this was the value given for the transmitter amplifier tube. The signal voltage was then adjusted to give an output approximately equal to the average value obtained on tests of the transmitter. In subsequent tests the plate voltage and signal voltage were increased to obtain the increased power desired.

c) The signal voltage was set initially and after each shut down. The shut downs were at approximately 30 minute intervals throughout the 20 hour tests.

the 30 hour test."

d) The total plate supply current was recorded before each shutdown with signal voltage on and after each shutdown before the signal voltage was turned on again.

e) The grid current was recorded and averaged approximately each hour during the 20 hour tests.

f) On the first few tests, before it was known how long the tubes would last, static tests were run after about 10 hours operation. This was discontinued when it was seen to be no longer necessary, and only one static test at the end of 20 hours of operation was made.

g) The shutdowns consisted of turning off all voltages on the tubes, allowing heater filaments to lose their visible glow and then again applying tube heater, plate, and signal voltages in that order.

h) Wave shape was observed several times during each test on two or three tubes for the first tests and later on all tubes.

first tests and later on all tubes.

ing each test on the air tight top the

j) Each anode was observed careful after

voltages in that order.

again applied zero bypass plate, and signal

filaments to just their initial glow and then

all voltages on the tubes, allowing heater

i) The shutdown consisted of turning off

at the end of 20 hours of operation was made.

no longer necessary, and only one static test

tion was discontinued when it was seen to be

tests were run after about 15 hours operation,

known how long the tubes would last. Static

f) In the first few tests, before it was

tests.

approximately most load during the 20 hour

e) The plate current was recorded and observa-

mal voltage was turned on again.

ure on and after each shutdown before the nor-

cated before each striking with normal volt-

a) The total plate supply current was re-

Description of Individual Tests

Test 1 - 30 hours. Average Power ≐ 0.8 watt/tube. Tubes - 8A1-8A10. (These tubes had been operated under varying conditions for several hours prior to test in setting up the test circuit).

Tube 8A-10 failed after 30 minutes operation. The failure was noted by the sharp drop in plate supply voltage, and a sharp rise in total plate current. When this tube was placed in the tester, its heater circuit drew only about one third normal current, plate voltage would not build up, plate current rose quickly to many times its normal value as plate voltage was applied and its indicated transconductance was almost zero.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	10.3 m.a.	8.9 m.a.	-1.4 m.a.

Description of Individual Tests

Test 1 - Mr. Homer's Analytic Power § 1.

"Watkyns". Tupee = Dyf-cric9. (Those three
not pooh elevated number varied eighteen
for caused penta Brian be text in analyt-
ab the book atrend)."

Tune ex-ip Delno eyes 20 mighed
chearlyin". The failure was mated by the
sharp rise in total pimpo current. Ayes
sport fast in pluto exotic xylets' Yul a
tute fund are pleund in the tayin' its
tached scarred' lyre adjuge ought not
vanter dimonic dyne only vector one ajred
pritt al' pimpo cantent lyne circuit it dark
given its exact nelon so pimpo eighth mes
mes almost sauce".

Pioneer at pure tuque in stimulate with Dent'
Delore test eight Test Cruise
Variable Pimpo
Current I=I.2 m'a". E'S I=I". -ing rate"

Before Test	After Test	Change
Average Trans-conductance 3460 micromhos	3320 micromhos	-140
Maximum Change in Plate current due to test	-1.6 m.a.	
Maximum Change in Transconductance due to test	-280 micromhos	

Average grid current during test: 0.28 m.a.

Plate Supply Voltage 145 V. for 10 hours; 150 V. for 10 hours; Average Signal voltage 4.83 V. (r.m.s.).

Remarks: Failure of Tube SA-10 attributed to use prior to this test.

Test 2 - 20 hours. Average Power ≐ 0.81 watt/tube. Tubes - SN1-SN10. No failures occurred during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	15.8 m.a.	12.0 m.a.	-3.8
Average Trans-conductance	4295 micromhos	3885 micromhos	-408

Maximum Change in transconductance due to test -860

Average grid current during test 0.255 m.a.

Plate Supply Voltage 130 V. Average Signal Voltage 4.27 V. (r.m.s.)

Test 3 - 20 hours. Average Power ≐ 1.12 watts/tube. Tubes SR11-SR18, SR20, SR21.

No failures occured during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	16.1 m.a.	10.4 m.a.	-5.7
Average Transconductance	4371 micromhos	3053 micromhos	-1318

Maximum Change in Plate Current due to test -8.9 m.a.

Maximum Change in Transconductance due to test -1800 micromhos

Average grid current during test 0.145 m.a.

Plate supply voltage 165,170,180 V. Average Signal voltage 6.04V (r.m.s.)

Test 4 - 20 hours. Average Power ≐ 1.6 watts/tube. Tubes SC-2-SC7, SC9, SC10, SC11, SC13. No failures occurred during test. Tube SC1 failed to operate when test was started. This tube tested perfectly on static test and had not been used between static and dynamic tests.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	11.7 m.a.	6.5 m.a.	-5.2
Average Transconductance	3899 micromhos	2447 micromhos	-1452

Maximum Change in Plate Current due to test -7.5 m.a.

Maximum Change in Transconductance due to test -1980 micromhos

Average grid current during test 0.189 m.a.

Plate supply voltage 200 V. Average Signal Voltage 6.24 V. (r.m.s.)

Neptune 6°29 λ° (Lemon)

Plate anglÿ neptune 326 λ° Panama (Lemon)

Venerie fÿf eastamp Earlÿe pate 0°32A mo°

rang -128E eleronpoe

Maximum change in Declination-Rate due to

-0°3 mo°

Maximum change in Plate Scales are no more

Equatorial Zone Nigeria Lagos Ex- -1°2E

Venerie Trans-

Eastern Zone Ivory Coast Ghana

Jupiter Zone Eclipse Zone

Element of Orbit Subject to Constant/or Slÿ Ratÿ

simple and dynamic centre.

Rapide case and Inv Ins Pass nice Calcaes

Apparent. Lÿte tube Created Earlÿeatÿ ne

Tube Adj Ÿritmd ÿt ncerate mine rear ma

Eclÿ. Ne Initiate measured Saturi Pealÿ

Mercÿ/Jupe. Trine Se-Ecl° Ale° Eclÿ° inÿÿ°

Zone 4 = 20 hours. Average Power @ 1.6

Test 5 - 20 hours. Average Power ≐ 1.8 watts/tube. Tubes SA11-SA20. No failures occurred during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	10.9 m.a.	7.31 m.a.	-3.59
Average Transconductance	3572 micromhos	2624 micromhos	-948

Maximum Change in plate current due to test -6.2

Maximum Change in Transconductance due to test -1440 micromhos

Average grid current during test 0.258 m.a.

Plate Supply Voltage 200 V. Average Signal Voltage 6.02 V. (r.m.s.)

Test 6 - 20 hours. Average Power ≐ 0.60 watt/tube. Tubes RA-1-RA6, RA8, RA-9, RA10. No failures occurred during test.

Test 8 - 30 hours. Examine Items 5 to 9.

Type SLJ-9280. No failures

Record all data taken in connection with test.

Before Test After Test Check

Variable Items

Maximum Error in Thermocouple Box is

Maximum Error in Thermocouple Box is

Test -1440 minutes

Examine grid contact during Test 7.110 m.

Place rubber Tetrafe SDC 4. Examine fitted

Alpha 1.02 " (1.0+0")

No failures occurred during test.

Test 8 - 30 hours. Examine Items 5 to 9.

Type SLJ-9280. No failures

	Before Test	After Test	Change
Average Plate Current	11.7 m.a.	10.95 m.a.	-.75
Average Transconductance	4150 micromhos	3920 micromhos	-230

Maximum Change in Plate Current due to test -2.2 m.a.

Maximum change in Transconductance due to test -530 micromhos

Average grid current during test 0.611 m.a.

Plate Supply Voltage 135V. Average Signal Voltage 4.87 V. (r.m.s.)

Remarks: On some tubes the output wave showed distortion in addition to the usual flat portions. The tubes in which this distortion appeared however, were no different in static characteristics from the other tubes.

Test 7- 20 hours. Average Power ± 1.2 watts/tube. Tubes RR1-RR10. No failures occurred during test.

Test 7- 80 hours. Average Power 3 k.w watts/tube. Tubes PPI-PPIO. No failures occurred during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	10.66 m.a.	11.16 m.a.	+0.50
Average Transconductance	3982	3863	-119

Maximum Change in Plate Current due to test +2.7 m.a.

Maximum Change in Transconductance due to test -340 micromhos

Average grid current during test 0.288 m.a.

Plate Supply Voltage 200V. Average Signal Voltage 5.09 V. (r.m.s.)

Remarks: Output wave on some tubes showed considerable "jitter" in amplitude (see Photograph #3). The maximum amplitude of the wave was not clearly defined but covered three or four small divisions on the Cathode Ray Tube scale. The tubes in which this was observed showed no differences on static test from the other tubes.

Test 8 - 20 hours. Average Power ≐ 1.59 watts/tube. Tubes RC1-RC10. No failures occurred during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	8.91 m.a.	9.50 m.a.	+0.62
Average Transconductance	3626 micromhos	3531 micromhos	-95

Maximum Change in Plate current due to test +6.0 m.a.

Maximum Change in Transconductance due to test -800 micromhos

Average grid current during test 0.326 m.a.

Plate Supply Voltage 235 V. Average Signal Voltage 6.25 V. (r.m.s.)

Remarks: Same as for Test 7.

Test 9 - 20 hours. Average Power ≐ 1.45 watts/tube. Tubes RC11-RC20. No failures occurred during test.

Summary of data taken in connection with test:

	Before Test	After Test	Change
Average Plate Current	8.67 m.a.	8.35 m.a.	-0.32
Average Trans-conductance	3534 micromhos	3437 micromhos	-97

Maximum Change in Transconductance due to test -500 micromhos

Average grid current during test 0.336 m.a.

Plate Supply Voltage 235 V. Average Signal Voltage 6.26 V. (r.m.s.)

A comparison of the changes of tube parameters with use can be quickly obtained by reference to the table below. The first test made on Manufacturer "S" Tubes has been omitted because of the use of these tubes prior to testing.

Manufacturer "A" Tubes

Test	$P_{average\ tube}$ (watts)	Milliamps Change in Ave. I_{plate}	Micromhos Change in Ave. G_m	% change in G_m
2	0.81	-3.30	- 408	9.52
3	1.12	-5.70	-1318	30.15
4	1.60	-5.20	-1462	37.35
5	1.50	-3.59	- 948	26.55
Aver.	1.26	-4.94	-1031	25.9

Manufacturer "B" Tubes

6	0.60	-0.75	-230	5.55
7	1.20	+0.50	-119	2.98
8	1.59	+0.62	- 95	2.62
9	1.49	-0.32	- 97	2.75
Aver.	1.22	+0.012	-135.2	3.48

Photographs which follow are typical output voltage wave forms on the oscilloscope for different tubes.

Temperature "C" Tubes

Test	Average Potential Gradient	Difference in Charge in 1m	Difference Microcoulombs	% change in C_0
	Ave. Effective Alt.			
7	1.87	-3.00	- 600	3.03
8	1.12	-4.70	-1318	30.13
4	1.20	-3.30	-1345	24.83
5	1.80	-2.00	- 640	12.33
Aver.	1.34	-4.14	-1021	17.8

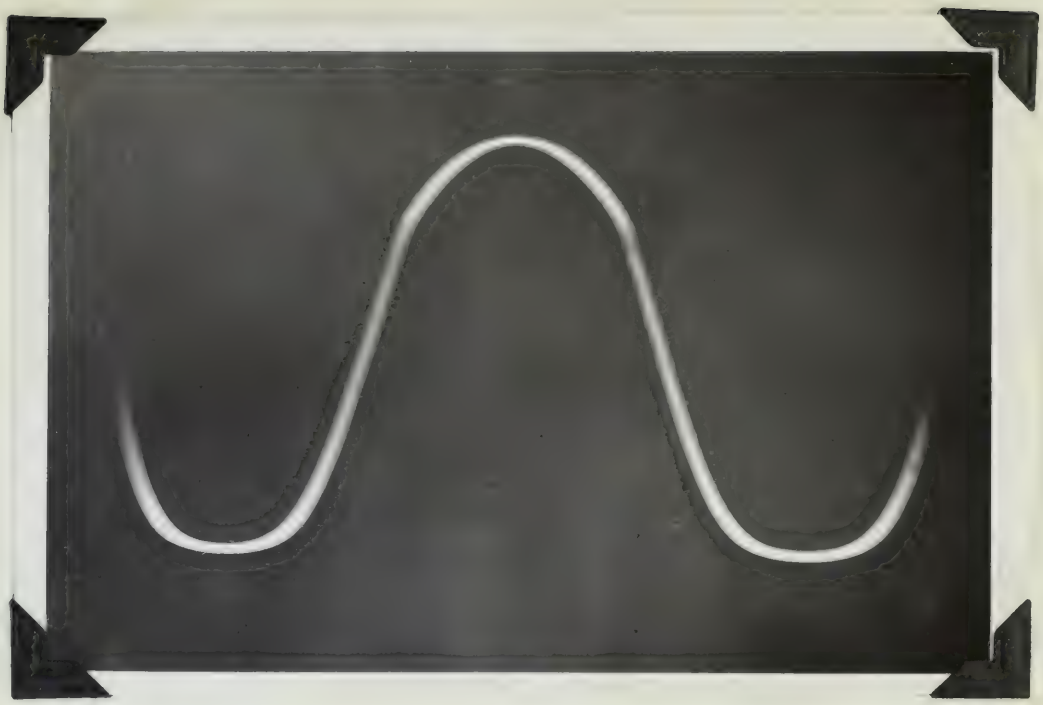
Temperature "D" Tubes

6	0.60	40.78	-230	8.85
7	1.20	40.80	-119	2.06
8	1.80	40.82	- 38	1.02
9	1.40	-0.22	- 97	2.78
Aver.	1.22	40.013	-122.3	3.44

Photographs which follow are typical

small voltage were taken to the beginning

for different times.



Manufacturer "S" Tube

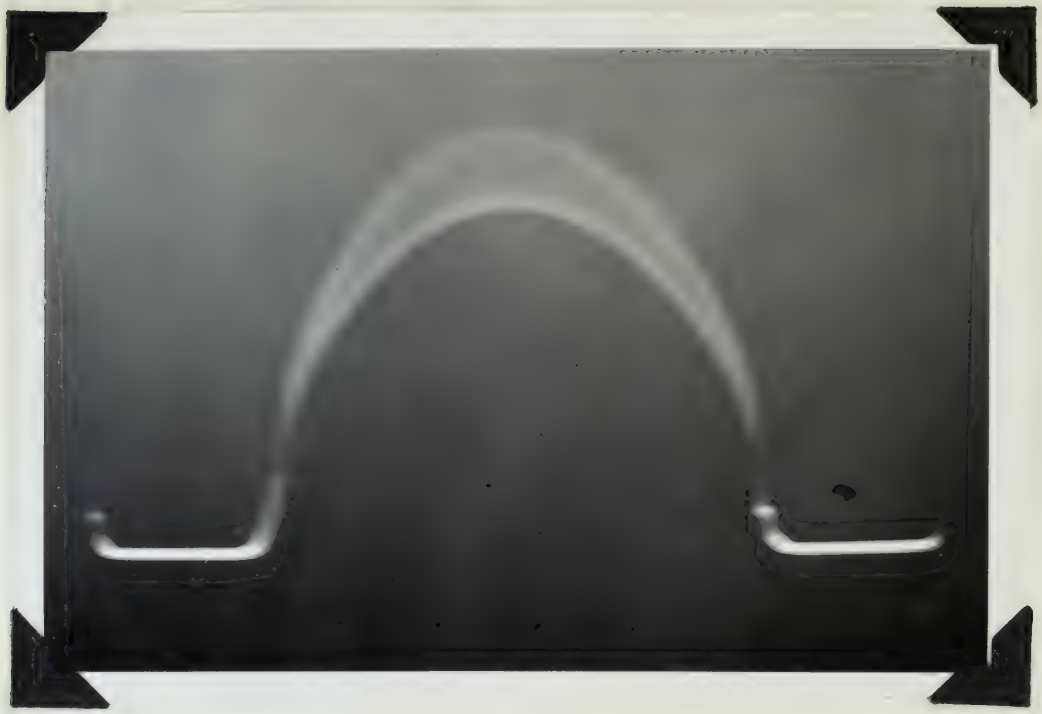
Output Voltage Wave

Photograph 1

Manufacturer "B" Tube

Output Voltage Wave

Photograph 2



Manufacturer "R" Tube
Output Voltage Wave, illustrating "noise" or "jitter"
appearing on some Manufacturer
"R" Tubes - Photograph 3.

№ Типы - фотограф Е.

аппаратик со звуко Внимательнее.

тратит "ноты" от "Дуэли"

-ящий Дуэлист Синий ящик-

Внимательнее № Типы

Upon completion of the nine tests described above, it was decided that sufficient data had been obtained on the short time capabilities of the tubes. Supplementary tests were run to determine how long tubes would operate before failing completely; or if this was not possible, due to excessive time requirements, what comparative changes in tube characteristics and power output would occur due to operation. Tests Four and Nine were continued with the same tubes operating at the same plate and signal voltages until each set of tubes had operated for 60 hours. The tubes were operated continuously for periods of about eight hours with no shutdowns until the 60 hours operation was completed. The following results were obtained from these tests:

a) No failures occurred on either Manufacturer "S" or Manufacturer "R" Tubes.

b) The total changes in parameters for the

60 hour tests were as tabulated below:

	Average G_m after 60 hrs.	Average G_m before test	Average ΔG_m	Average ΔI_{plate}
Manufacturer "S" Tubes SC2-7,9,10,11, 13	2667	3899	-1232	-5.03
Manufacturer "R" Tubes RC11 - 20	3528	3534	- 6	40.40

G_m in micromhos

I_{plate} in milliamps

c) Tubes SC4 and RC13 respectively were the low tubes in power output during the twenty hour tests. During 52 hours operation Tube SC4 power output dropped 22%. During 55 hours operation Tube RC13 power output did not change.

Since there were no failures on either manufacturer's tubes due to the Dynamic Tests, it cannot definitely be stated that Manufacturer "R" Tubes will outlast Manufacturer "S"

Tubes. It seems definitely proven however, that the characteristics of Manufacturer "T" Tubes change less with operation under normal and overload conditions than do the characteristics of Manufacturer "S" Tubes. This change in characteristics results in the loss of power output observed in Manufacturer "S" Tubes.

CHAPTER IV

ATTEMPTED CORRELATION BETWEEN STATIC TESTS AND TUBE CHARACTERISTICS DURING LIFE

As was stated in the introduction, one of the purposes of the tests was to predict tube life under dynamic conditions from measurements made in a static tester. The following attempts at correlation were made. It is important to note that on the twenty hour tests of fifty Manufacturer "S" and forty Manufacturer "R" Tubes, there was but one failure. This failure occurred after 1/2 hour on a tube which prior to the actual test had been operated several hours at many different voltages in the simulator while the simulator was being set up. Because there was only one failure and this was on a tube whose g_m was only 1700 micromhos at the beginning of the test, as compared to 5700 micromhos average for the lot from which it was taken, the failure cannot be attributed

to the operation during the test period.

Since there were no failures of normal tubes, the best method of measuring useful life left in the tubes after test is to measure their transconductance. In the following attempts at correlation, this criterion was used.

The change in transconductance between normal plate voltage and normal plate voltage less 20 volts was computed from static tests. This change was compared with the final value of transconductance. The results showed no apparent correlation between change in g_m and final value of g_m as will be seen by referring to the tables below which are for tubes used in two separate tests.

Tube	Original g_m micromho	Final g_m Micromho	Δg_m for E_b plate lowered 20 volts
5A-1	3600	3100	-725
2	3500	3000	-700
3	3920	3680	-1020
4	4320	3200	-825

4	4320	3800	-952
3	3080	3000	-1020
2	3800	3000	-400
3V-y	2800	3100	-728

Tube	Original g_m micromho	Final g_m Micromho	ΔG_m for E_{plate} lowered 20 volts
5A-5	4200	3600	-870
6	3450	3300	-900
7	3500	3000	-800
RR-1	3630	3600	-630
2	4300	4270	-670
3	4000	3700	-530
4	3800	3730	-650
5	4550	4600	-650
6	3620	3300	-450
7	4150	3950	-550
8	3670	3520	-445
9	3900	3560	-520
10	4200	4400	-680

Similar comparisons made with ten other tubes of each type also failed to show any correlation between change in g_m and final value of g_m.

The next change investigated for possible relation to the final value of g_m

Type	Critical Separation	Final ΔE_p	ΔE_p for Planar Lowered 20
CH$_2$-B	4800	2500	-810
E	6430	4320	-460
I	8800	8000	-600
H-I	9420	9000	
F	4700	4270	-810
S	8000	3400	-830
A	3600	8320	-460
E	4860	4000	-420
C	9820	3800	-490
T	4190	1980	-190
D	8070	9880	-440
S	6700	2460	-850
Pb	4800	4650	-220

Dimeter comparisons made with ten

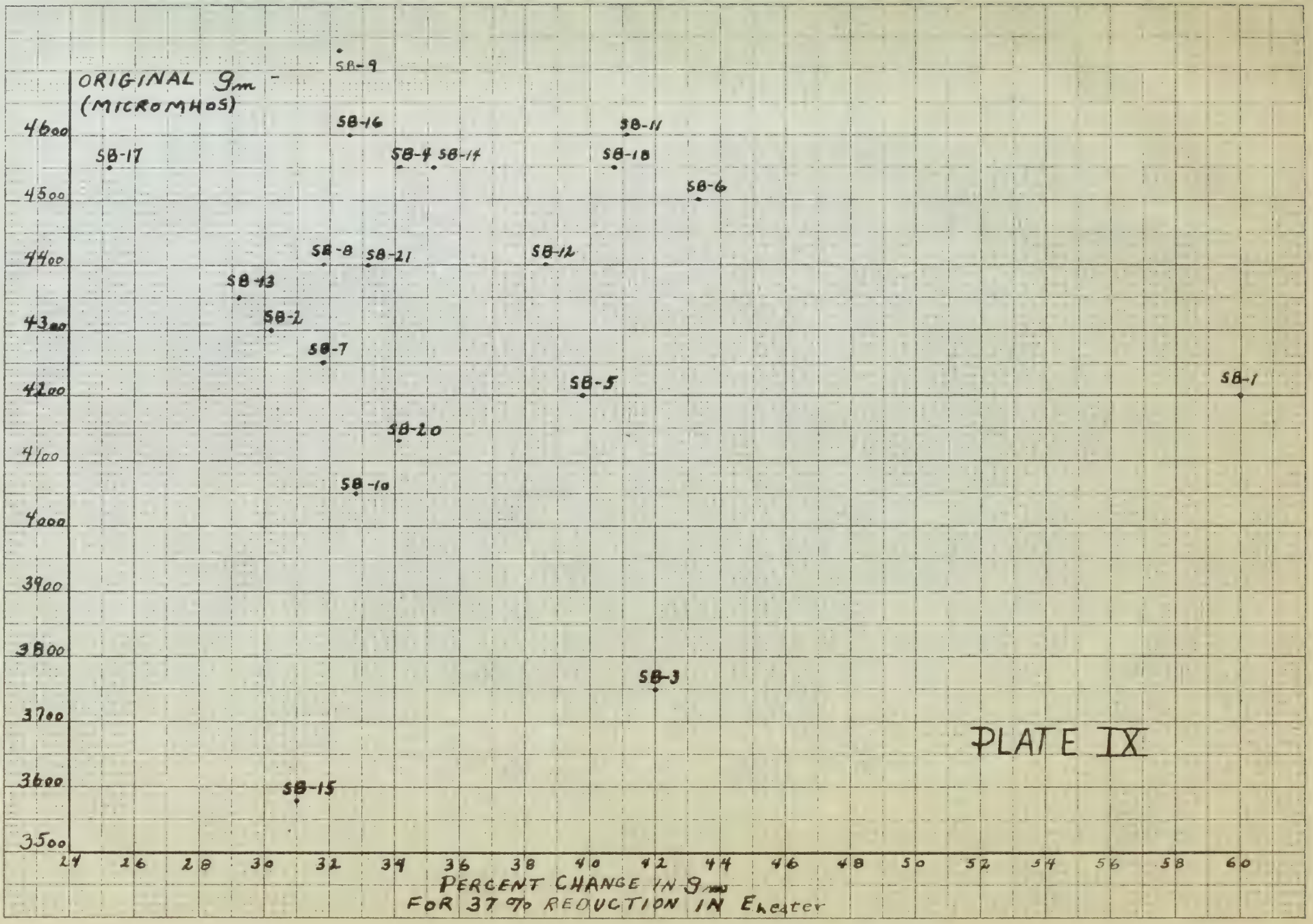
Other types of ions tried were

and correlation between steps in $E_{1/2}$ and first

The next step is investigating for

Lethe of K^+.

was the change in transconductance for a reduction in heater voltage from 6.3 to 4.0 volts. The percentage change in g_m at 4.0 volts was computed, and this was plotted against original g_m for several of the tubes of both manufacture that had been tested dynamically. It was thought possible that with such a plot one would be able to select quickly desirable tubes which had high g_m and small change in g_m for change in heater voltage. The data from which two such plots were made appears in Table I of Appendix II together with the predictions on the relative values of transconductance at the end of twenty hours operation. The tube which it was predicted would have highest value of g_m at the end of twenty hours operation was called 1st, the tube predicted to have next highest value 2nd and so forth. These predictions were made by using the plots of Plates IX and X. At the same time predictions were made on the


ORIGINAL 9mm
(MICROMHOS)
SB-9
SB-16
SB-11
SB-17
SB-4
SB-14
SB-18
SB-6
SB-8
SB-21
SB-12
SB-13
SB-2
SB-7
SB-5
SB-1
SB-20
SB-10
SB-3
SB-15
46oo
45oo
44oo
43oo
42oo
41oo
4000
3900
3800
3700
3600
3500
24
26
28
30
32
34
36
38
40
42
44
46
48
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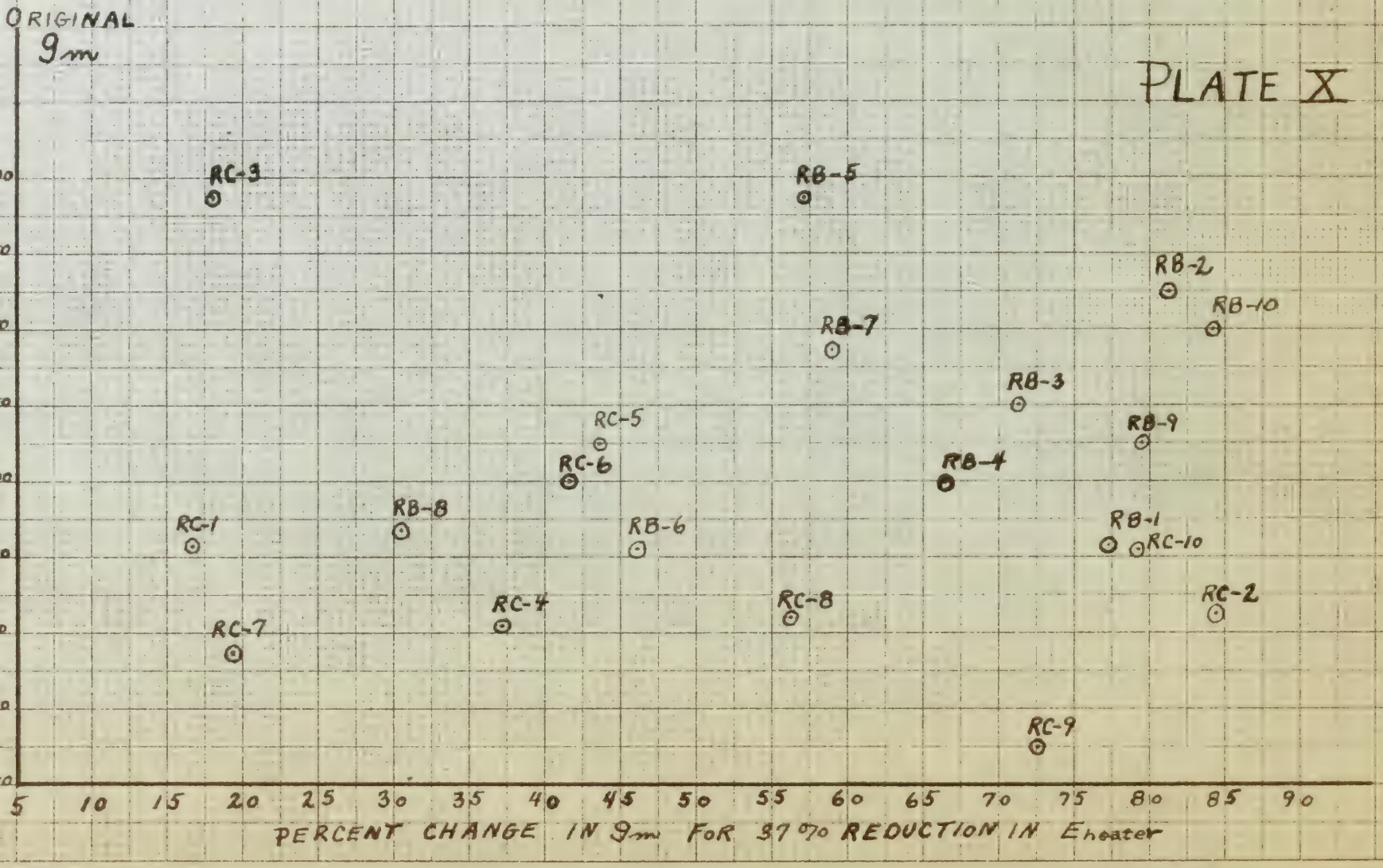
54
56
58
60
PERCENT CHANGE IN 9mm
FOR 37% REDUCTION IN Ehester
PLATE IX

PLATE X


ORIGINAL
9m
4600
4400
4200
4000
3800
3600
3400
3200
3000
RC-3
RB-5
RB-2
RB-10
RB-7
RB-3
RC-5
RB-9
RC-6
RB-4
RB-8
RC-1
RB-6
RB-1
RC-10
RC-2
RC-4
RC-8
RC-7
RC-9
5
10
15
20
25
30
35
40
45
50
55
60
65
70
75
80
85
90
PERCENT CHANGE IN 9m FOR 37% REDUCTION IN Eheater

basis of original value of G_m alone. The errors in predicting the relative values of G_m after twenty hours operation by use of the plot and by use of the original value of G_m are given below for two groups of ten tubes each.

Tube	Error in relative G_m after operation using original G_m to predict	Error in relative G_m after operation using plot to predict
SP-11	4	1
12	6	1
13	0	1
14	2	0
15	1	3
16	0	1
17	0	1
18	1	4
20	3	1
21	3	1
Average	2.0	Average 1.4
SB-1	2	1
2	1	2

Type	Error in relative using original E^m to predict	Error in relative using plot to predict
12-11	4	1
13	6	1
18	0	1
14	2	0
15	1	2
16	0	1
17	0	1
19	1	4
20	3	1
21	3	1
Average	2.0	Average 1.4
3-1	3	1
3	1	2

Tube	Error in relative g_m after operation using original g_m to predict	Error in relative g_m after operation using plot to predict
5B-3	1	1
4	2	2
5	1	1
6	2	7
7	1	2
8	2	1
9	2	2
10	2	1
Average	1.7	Average 2.0

The results of four more tests of twenty hours each were used to make identical calculations. The computations will not be shown here but the results were:

Tube	Average error in relative g_m after operation using original g_m to predict	Average error in relative g_m after operation using plot to predict
3C 2-13	2.60	3.40
5A 11-20	1.33	1.22
5B 1-10	1.00	2.80
5C 1-10	2.40	3.40

Type	Average error in relative E^m after observation using first approximation to predict	Average error in relative E^m after observation using final approximation to predict
BC J-J2	2.00	2.40
AV JJ-2B	1.21	1.12
AA J-J0	1.00	2.00
BC J-J0	2.40	2.40

The results of the six tests show that the average error in relative g_m after test is usually less by using the original value of g_m to predict value after test. These results preclude the use of the plot as tubes that start life with high g_m usually continue to have high g_m relative to tubes starting life with low g_m.

The next quantity investigated for its effect on tube life was plate resistance. Values of r_p were computed at rated heater voltage and at 4.0 volts heater voltage. The change in plate voltage in each case was 20 volts.

Results of these computations are given in Table II of Appendix II for ten Manufacturer "g" and nine Manufacturer "h" Tubes. The Δr_p is simply change in r_p for a change of -2.3 volts heater voltage.

There appears to be no correlation between Δr_p and final value of g_m nor between Δr_p and Δg_m.

No further attempts were made to correlate the results of Static Tests with tube characteristics during life. A search of available literature failed to disclose any information as to what attempts had been made by others to perform such a correlation aside from making the usual measurements in a tester of Plate Current, Plate Resistance, and Transconductance at rated values of Plate and Heater Voltage.

Chapter V

Conclusions

On the basis of static tests, Manufacturer "R" Tubes are more uniform in characteristics than Manufacturer "S" Tubes. "R" Tubes show fewer percentages of bad tubes from a random selection. Their parameters are more nearly what their manufacturers give as typical parameters.

The average value of transconductance, which is usually considered the best criterion of design proficiency of a tube, was greater for 98 Manufacturer "R" Tubes than for an equal number of Manufacturer "S" Tubes.

On the basis of dynamic tests simulating performance in one particular application, Manufacturer "R" Tubes show much smaller percentage change in both static characteristics and power output than Manufacturer "S" Tubes. While no definite value of tube life was obtained for either manufacturer's tubes, it

Conclusions

Chapter

is highly probable that Manufacturer "B" Tubes will outlive Manufacturer "S" Tubes.

No simple method is apparent from the results of these experiments by which the parameters measured on static tests can be used to predict changes in characteristics which may result from tube operation.

APPENDIX I

TABLE I

Manufacturer	Manufacturer's Lot No.	Symbol	Number of Tubes	Tube Design Times
"A"	R25589D	SA	35	SA1, SA2,...SA35
"B"	R25589C	SB	35	SB1, SB2,...SB35
"C"	R26255	SC	35	SC1, SC2,...SC35
		Total	105	
"D"	148	RA	10	RA1, RA2,...RA10
"E"	298	RB	26	RB1, RB2,... RA26
"F"	438	RC	24	RC1, RC2,...RC24
"G"	488	RD	40	RD1, RD2,...RD40
		Total	100	

TABLE II

Manufacturer "B" - 6KhA Tubes

Tube	Milliamp Iplate	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
BA 1	10.0	3600	4760	1.2	360	95
" 2	10.3	3500	4760	.9	360	195
" 3	11.7	3920	4760	.5	360	225
" 4	12.8	4320	4445	1.6	45	625
" 5	13.5	4200	3840	2.3	560	505
" 6	9.5	3450	4650	1.7	250	245
" 7	11.3	3500	3840	.1	560	195
" 8	16.0	4400	3510	4.8	890	705
" 9	10.0	3350	4650	1.2	250	345
" 10	9.0	3120	4760	2.2	360	575
" 11	14.0	4170	3510	2.8	890	475
" 12	14.1	3900	3840	2.9	700	205
" 13	8.8	3270	5125	2.4	725	425
" 14	11.5	3650	4080	.3	320	45
" 15	9.1	3370	5125	2.1	725	325
" 16	9.0	3300	48.75	2.2	475	395
" 17	11.6	3700	4000	.4	400	5
" 18	10.3	3480	4545	.9	115	215

Tube	Yields	Elongation	Ultimate Strength	Initial Tension Tensile Lb.	Variation from mean Lb.
1	10.0	3400	47000	1.1	300
2	10.3	3200	47000	.7	300
3	11.7	3700	47000	.1	300
4	11.5	4200	48000	1.8	15
5	11.5	4300	48000	1.3	100
6	9.5	3400	46000	1.7	200
7	11.3	3700	47000	.1	300
8	10.0	4000	47000	1.8	100
9	12.0	3700	46000	1.1	200
10	1.0	3200	47000	2.6	300
11	11.5	4400	37000	2.8	800
12	11.1	3700	36000	2.9	700
13	6.5	3200	43000	2.6	700
14	11.4	3400	46000	.3	300
15	9.1	3200	43000	2.1	700
16	9.0	3300	48.75	2.5	475
17	11.0	3700	46000	.6	4000
18	10.3	3400	47000	.9	300

Tube	Milliamp Iplate	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
6A19	8.7	3350	5125	2.5	725	345
" 20	11.9	3600	4000	.7	400	95
" 21	12.5	3820	3840	1.3	560	125
" 22	15.2	4400	3390	4.3	1010	705
" 23	15.8	4620	3570	4.6	830	925
" 24	9.0	3320	5000	2.2	600	375
" 25	10.4	3600	4445	.8	45	95
" 26	9.1	3300	5260	2.1	860	395
" 27	12.3	3870	3920	1.1	480	175
" 28	Bad Tube					
" 29	8.5	3400	5550	2.7	1150	295
" 30	11.7	3920	4445	.5	45	225
" 31	11.7	3950	4080	.5	320	255
" 32	10.5	3700	4445	.7	45	5
" 33	13.0	3720	3840	1.8	560	25
" 34	8.7	3240	5125	2.5	725	455
" 35	9.8	3500	4450	1.4	250	195
Totals	381.3	125510	149610	60.2	16000	10010
Average =	1/34 x Totals 11.20	3695	4400	1.77	470	312

Tree	Height	Circumference	Time to reach 12	Time to reach 24	Time to reach 36
	ft.	in.	yrs.	yrs.	yrs.
Max	8.7	1176	6.5	15	245
* 8	12.3	2688	4.7	14	15
* 11	12.5	2580	3.3	10	142
* 12	12.4	2480	4.3	12	194
* 13	12.2	2500	4.4	13	213
* 14	7.6	2420	4.7	10	171
* 15	12.3	2400	4	12	19
* 16	7.1	2280	4	10	196
* 17	11.3	2240	3.1	10	152
* 18	Died Young				
* 19	8.1	2200	4.3	12	194
* 20	12.1	2180	4	12	202
* 21	12.1	2040	4	10	178
* 22	10.2	2020	4	12	3
* 23	12.0	2020	3.3	10	25
* 24	8.7	2020	4.1	11	177
* 25	6.3	2000	3.4	10	152
Total = 301.3		247280	84.1	13000	10480
Average = 12.0 = Total ÷					
	12.08	2047	3.77	520	324

TABLE III

Manufacturer "S" - 6SLA Tubes

Tube	Milliamp Ipkts	Microamps Ikk	Ohms Rp	Variation from mean Ip	Variation from mean Rp	Variation from mean Ikk
SB 1	14.4	4200	4000	1.4	530	120
" 2	14.4	4300	3700	1.2	230	20
" 3	12.1	3750	4080	3.5	610	570
" 4	16.9	4550	3330	1.3	140	230
" 5	15.5	4200	3640	0.1	170	120
" 6	17.1	4500	3080	1.5	390	180
" 7	15.8	4250	3180	.2	290	70
" 8	15.0	4400	3445	.6	25	80
" 9	17.3	4730	3180	1.7	390	410
" 10	14.0	4050	3450	1.6	20	270
" 11	19.0	4000	2990	3.4	420	280
" 12	17.3	4400	3445	1.7	25	80
" 13	14.4	4350	3510	1.2	40	30
" 14	16.8	4550	3330	1.2	140	230
" 15	11.9	3580	3920	3.7	450	748
" 16	15.8	4600	3510	.2	40	280
" 17	15.6	4550	3700	.0	230	230
" 18	18.4	4550	2940	3.2	530	230

Tube	Milliamp Iplate	Micromho g_m	Ohms r_p	Variation from mean I_p	Variation from mean r_p	Variation from mean g_m
19	Bad Tube					
20	16.5	4130	3510	.9	40	190
21	15.5	4400	3700	.1	230	80
22	19.0	4580	3175	3.4	295	260
23	12.3	3900	3775	3.3	305	420
24	13.1	4200	3575	2.5	105	120
25	18.2	4400	3125	2.6	345	80
26	17.3	4600	3175	1.7	295	280
27	16.0	4420	3640	.4	170	100
28	15.3	4070	3390	.3	80	250
29	15.3	4320	3970	.3	100	0
30	15.3	4200	3390	.3	80	120
31	15.6	4400	3700	.0	230	80
32	16.3	4600	3450	.7	20	280
33	Bad Tube					
34	13.1	3820	3510	2.5	40	500
35	14.5	4460	3390	1.1	80	160
Totals	521.0	142630	114505	47.6	7145	7090
Average = 1/33 x Total						
	17.6	4320	3470	1.44	216.2	214.7

Item	Quantity	Rate	Amount	Tax	Total
1	10	100.00	1000.00	18%	1180.00
2	5	200.00	1000.00	18%	1180.00
3	20	50.00	1000.00	18%	1180.00
4	1	5000.00	5000.00	18%	5900.00
5	100	10.00	1000.00	18%	1180.00
6	2	750.00	1500.00	18%	1770.00
7	50	20.00	1000.00	18%	1180.00
8	3	333.33	999.99	18%	1180.00
9	15	66.67	1000.05	18%	1180.00
10	8	125.00	1000.00	18%	1180.00
11	4	250.00	1000.00	18%	1180.00
12	12	83.33	999.96	18%	1180.00
13	6	166.67	1000.02	18%	1180.00
14	25	40.00	1000.00	18%	1180.00
15	7	142.86	1000.02	18%	1180.00
16	9	111.11	999.99	18%	1180.00
17	30	33.33	999.90	18%	1180.00
18	40	25.00	1000.00	18%	1180.00
19	11	90.91	1000.01	18%	1180.00
20	14	71.43	1000.02	18%	1180.00
21	60	16.67	1000.20	18%	1180.00
22	35	28.57	999.95	18%	1180.00
23	45	22.22	999.90	18%	1180.00
24	18	55.56	999.96	18%	1180.00
25	22	45.45	999.90	18%	1180.00
26	13	76.92	999.96	18%	1180.00
27	16	62.50	1000.00	18%	1180.00
28	27	37.04	999.99	18%	1180.00
29	17	58.82	999.94	18%	1180.00
30	24	41.67	1000.08	18%	1180.00
31	19	52.63	999.97	18%	1180.00
32	21	47.62	999.99	18%	1180.00
33	26	38.46	999.96	18%	1180.00
34	28	35.71	999.88	18%	1180.00
35	23	43.48	999.99	18%	1180.00
36	31	32.26	999.86	18%	1180.00
37	29	34.48	999.92	18%	1180.00
38	32	31.25	1000.00	18%	1180.00
39	33	30.30	999.90	18%	1180.00
40	34	29.41	999.94	18%	1180.00
41	36	27.78	1000.08	18%	1180.00
42	37	27.03	999.99	18%	1180.00
43	38	26.32	999.92	18%	1180.00
44	39	25.64	999.96	18%	1180.00
45	41	24.39	999.99	18%	1180.00
46	42	23.81	999.90	18%	1180.00
47	43	23.26	999.98	18%	1180.00
48	44	22.73	999.92	18%	1180.00
49	46	21.74	999.96	18%	1180.00
50	47	21.28	999.96	18%	1180.00
51	48	20.83	999.84	18%	1180.00
52	49	20.41	999.89	18%	1180.00
53	50	20.00	1000.00	18%	1180.00
54	51	19.61	999.99	18%	1180.00
55	52	19.23	999.96	18%	1180.00
56	53	18.87	999.91	18%	1180.00
57	54	18.52	999.96	18%	1180.00
58	55	18.18	999.90	18%	1180.00
59	56	17.86	999.96	18%	1180.00
60	57	17.54	999.78	18%	1180.00
61	58	17.24	999.92	18%	1180.00
62	59	16.95	999.99	18%	1180.00
63	60	16.67	1000.20	18%	1180.00
64	61	16.39	999.79	18%	1180.00
65	62	16.13	999.86	18%	1180.00
66	63	15.87	999.81	18%	1180.00
67	64	15.63	1000.32	18%	1180.00
68	65	15.38	999.70	18%	1180.00
69	66	15.15	999.90	18%	1180.00
70	67	14.93	1000.31	18%	1180.00
71	68	14.71	999.88	18%	1180.00
72	69	14.49	999.81	18%	1180.00
73	70	14.29	1000.30	18%	1180.00
74	71	14.08	999.68	18%	1180.00
75	72	13.89	1000.08	18%	1180.00
76	73	13.70	999.10	18%	1180.00
77	74	13.51	999.74	18%	1180.00
78	75	13.33	999.75	18%	1180.00
79	76	13.16	999.76	18%	1180.00
80	77	12.99	999.73	18%	1180.00
81	78	12.82	999.96	18%	1180.00
82	79	12.66	1000.14	18%	1180.00
83	80	12.50	1000.00	18%	1180.00
84	81	12.35	999.35	18%	1180.00
85	82	12.20	1000.40	18%	1180.00
86	83	12.05	999.15	18%	1180.00
87	84	11.90	999.60	18%	1180.00
88	85	11.76	999.60	18%	1180.00
89	86	11.63	1000.18	18%	1180.00
90	87	11.49	999.63	18%	1180.00
91	88	11.36	999.68	18%	1180.00
92	89	11.24	1000.36	18%	1180.00
93	90	11.11	999.90	18%	1180.00
94	91	10.99	1000.09	18%	1180.00
95	92	10.87	1000.04	18%	1180.00
96	93	10.75	999.75	18%	1180.00
97	94	10.64	1000.16	18%	1180.00
98	95	10.53	999.85	18%	1180.00
99	96	10.42	1000.32	18%	1180.00
100	97	10.31	999.07	18%	1180.00

TABLE IV

Manufacturer "S" - 6AL5 Tubes

Tube	Milliamp Ip Mils	Micromho Gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean Gm
S# 1	11.3	3400	3920	0	130	275
" 2	12.0	3920	3920	.7	130	245
" 3	10.3	3520	4445	1.0	295	155
" 4	13.8	4160	3570	2.5	580	485
" 5	8.2	3300	5950	3.1	1400	375
" 6	14.0	4350	3510	2.7	640	675
" 7	10.6	3820	4445	.7	295	145
" 8	Bad Tube					
" 9	10.6	3600	4350	.7	200	75
" 10	11.3	3750	4170	.0	80	75
" 11	13.4	4120	3920	2.1	230	445
" 12	Bad Tube					
" 13	12.8	4450	3775	1.5	375	775
" 14	14.3	4250	3125	3.0	1025	575
" 15	Bad Tube					
" 16	10.0	3060	4250	1.3	100	15
" 17	13.4	4470	3035	2.1	515	795
" 18	10.3	3350	4170	1.0	20	325

Tube	Milliamp Isolate	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
3019	14.5	3900	3570	3.2	580	225
" 20	10.6	3500	4000	.7	150	175
" 21	13.5	4190	3775	2.2	375	515
" 22	8.9	3330	5260	2.4	1110	345
" 23	10.6	3620	4080	.7	70	55
" 24	9.1	3300	4700	2.2	610	375
" 25	10.3	3500	4350	1.0	200	175
" 26	12.0	3800	3845	.7	305	125
" 27	10.1	3680	4255	1.2	105	5
" 28	11.3	3680	4170	0	20	5
" 29	Bad Tube					
" 30	9.5	3400	4700	1.8	610	275
" 31	13.5	3910	3700	2.2	450	235
" 32	8.8	3400	4000	2.5	70	275
" 33	12.3	3800	3700	1.0	450	125
" 34	12.0	3920	4250	.7	150	245
" 35	7.9	3200	5550	3.4	1400	475
Totals	351.2	116270	128860	48.3	12670	9065
Average = 1/31 x Totals						
	11.3	3675	4150	1.56	408	292

Tube	Intensity	Wavelength Å	Time sec	Width minutes arc	Width Cross sec.
1112	14.5	3260	3700	3.2	780	205
" 20	12.6	3700	4000	4.7	1.50	177
" 21	13.2	4130	3771	4.8	371	243
" 12	6.9	3630	4800	3.1	1110	318
" 21	24.6	3660	4400	4.7	70	55
" 16	9.1	3340	4700	1.4	610	175
" 11	12.3	3700	4350	1.8	300	125
" 19	12.8	3500	4214	4.7	304	114
" 17	20.1	3680	4414	1.3	144	5
" 10	11.3	3600	4330	0	44	5
" 18	Two Tubes					
" 30	9.6	3600	4700	1.4	600	177
" 31	10.7	3750	3700	1.3	450	142
" 32	6.8	3400	4200	4.5	72	228
" 33	12.3	3600	3700	1.0	180	145
" 34	12.9	3700	4400	4.7	180	144
" 37	14.1	3700	4300	1.3	3400	132
Totals	371.2	112000	122800	142.3	12870	4405
Averages	= 12/32	Tubes				
	11.3	3477	4250	1.34	400	138

TABLE V

Manufacturer "1" - CK6083X Tubes

Lot 148

Tube	Millimhos Ip Amps	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
No 1	10.3	4150	5260	1.4	940	0
" 2	12.0	3840	4650	.7	330	310
" 3	13.0	4220	3775	1.3	545	70
" 4	11.5	4400	4080	.2	240	250
" 5	13.4	4650	3970	1.7	400	500
" 6	10.3	3630	4160	1.4	160	520
" 7	Bad Tube					
" 8	12.2	4080	4250	.5	70	70
" 9	12.6	4320	4350	.9	30	170
" 10	11.0	4400	4445	.7	125	150
Totals	105.3	37290	38900	8.8	2840	2040
Average = 1/9 x Totals						
	11.7	4150	4320	.98	316	226.5

TABLE VI

Manufacturer "B" - [illegible] Tubes

Lot [illegible]

Tube	Milliamp Inlets	Microamp gm	Ohms rp	Variation from mean Ia	Variation from mean rp	Variation from mean gm
[illegible] 1	7.7	3630	6870	3.3	1370	350
" 2	12.4	4300	4075	1.4	805	320
" 3	11.5	4000	4760	.5	120	20
" 4	10.4	3800	5000	.6	120	180
" 5	13.3	4590	4000	2.3	800	570
" 6	10.2	3820	5010	.8	120	360
" 7	10.7	4170	4875	.3	5	170
" 8	9.1	3670	6450	1.9	1570	310
" 9	10.2	3900	4875	.8	5	60
" 10	11.1	4200	4250	.1	630	220
" 11	10.4	4000	5200	.6	520	20
" 12	13.2	4490	4000	2.2	880	470
" 13	10.7	3900	4870	.3	250	80
" 14	11.0	3840	4875	.0	5	110

Tube	Milliamps Plate	Microhos gm	Ohms rp	Variation from mean I_p	Variation from mean r_p	Variation from mean gm
RB15	12.3	4220	4445	1.3	435	240
" 16	13.1	4380	4550	2.1	330	400
" 17	10.8	3780	4760	.2	120	200
" 18	13.2	4200	4080	2.2	800	220
" 19	12.2	4020	4550	1.2	330	40
" 20	11.2	3820	4875	.2	5	100
" 21	10.2	3800	5200	.8	380	180
" 22	11.4	3800	4875	.4	5	180
" 23	9.2	3900	5700	1.8	820	80
" 24	9.8	3770	5125	1.2	245	210
" 25	10.7	4100	4650	.3	230	120
" 26	9.4	3700	5550	1.6	670	280
Totals	285.4	103500	128960	28.5	11550	5600
Average = 1/26 x Totals						
	11.0	3980	4880	1.095	444	215

Type	Initials	Qty.	Cost	Date Issued	Vouchers Drawn	Vouchers Paid
[illegible]	12.3	5000	1414	1.3	115	100
" 20	13.3	6100	1700	1.3	130	100
" 17	11.2	3700	1400	.2	115	000
" 18	13.4	4500	1500	1.1	[illegible]	[illegible]
" 14	11.1	4400	1400	1.1	130	10
" 21	13.7	3000	1477	.2	0	100
" 13	10.1	2500	1500	.2	130	100
" 12	11.2	3800	1477	.3	0	100
" 11	8.1	3400	1700	1.1	120	80
" 22	9.4	3170	1525	1.3	0	100
" 15	11.7	4300	1500	.1	130	100
" 16	8.1	1700	1500	1.2	100	000
Totals	127.7	48800	14000	11.7	11200	9000

Average = 1/12 = Totals

	12.4	3900	1400	1.000	100

TABLE VII

Manufacturer "X" - [illegible] Tubes

Lot 434

Tube	Milliamps Ignite	Microhos gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
No 1	10.3	3630	5260	2.3	670	30
" 2	8.0	3490	5715	.1	215	210
" 3	5.5	4570	7400	3.5	1470	890
" 4	8.4	3420	6900	.6	970	360
" 5	8.4	3900	5860	.6	50	240
" 6	11.5	3800	5000	2.5	930	140
" 7	10.4	3350	5400	2.4	530	310
" 8	10.2	3440	5325	1.2	805	80
" 9	7.0	3100	6450	2.0	520	900
" 10	8.2	3620	8340	.8	2410	40
" 11	7.6	3600	6000	1.4	130	60
" 12	8.7	3550	5720	.3	210	110

Tube	Milliamps Iplate	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
2013	8.6	3700	6450	.4	520	40
" 14	5.8	3080	8340	3.2	1410	580
" 15	10.2	3700	5400	1.2	530	160
" 16	10.2	3500	5400	1.2	530	160
" 17	7.6	3330	7150	1.4	1220	330
" 18	8.9	3480	6550	.1	380	180
" 19	10.9	4000	4700	1.9	1170	340
" 20	8.2	3600	6450	.8	520	60
" 21	Bad Tube					
" 22	10.4	4200	5130	1.4	800	940
" 23	10.2	4100	4760	1.2	1170	440
" 24	11.0	4200	3770	2.0	2360	600
Totals	207.3	84160	130210	30.5	20520	6460
Average = 1/23 x Totals						
	9.0	3660	5930	1.325	892	281

TABLE VIII

Manufacturer "A" - 6AC8GX Tubes

Lot 468

Tube	Milliamps Iplate	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
RD 1	9.1	3800	5400	.7	220	245
" 2	7.8	3040	6050	2.0	870	405
" 3	8.8	3800	5710	1.0	530	245
" 4	10.1	3900	4840	.3	640	145
" 5	9.8	3940	4880	0	300	105
" 6	9.0	3700	5710	.8	530	345
" 7	11.7	4420	4440	2.9	740	375
" 8	10.6	4180	4760	.8	420	135
" 9	10.4	4300	4670	.6	530	155
" 10	10.5	4120	4760	.7	420	75
" 11	10.4	4100	4880	.6	300	55
" 12	9.2	4000	5400	.4	220	45
" 13	8.6	4000	5880	1.2	700	45

Table XXII

Investigation "C" - Electric Tubes

Tube	Filament	Mfg.	Ef	Time in seconds	Vacuum time in seconds	Vacuum after burn
RD 1	1.1	[illegible]	[illegible]	.7	[illegible]	[illegible]
" 2	1.4	[illegible]	[illegible]	1.2	[illegible]	[illegible]
" 3	6.6	[illegible]	[illegible]	1.3	[illegible]	[illegible]
" 4	24.3	[illegible]	[illegible]	.3	[illegible]	[illegible]
" 5	4.3	[illegible]	[illegible]	0	[illegible]	[illegible]
" 6	4.0	[illegible]	[illegible]	.6	[illegible]	[illegible]
" 7	14.7	[illegible]	[illegible]	1.9	[illegible]	[illegible]
" 8	12.4	[illegible]	[illegible]	.8	[illegible]	[illegible]
" 9	12.7	[illegible]	[illegible]	.4	[illegible]	[illegible]
" 10	10.5	[illegible]	[illegible]	.7	[illegible]	[illegible]
" 11	10.4	[illegible]	[illegible]	.4	[illegible]	[illegible]
" 12	3.1	[illegible]	[illegible]	.1	[illegible]	[illegible]
" 13	6.6	[illegible]	[illegible]	1.1	[illegible]	[illegible]

Tube	Milliamps Ip	Micromho gm	Ohms rp	Variation from mean Ip	Variation from mean rp	Variation from mean gm
[illegible] 14	8.8	3870	5550	1.0	370	175
" 15	11.2	4000	4880	1.4	300	45
" 16	10.7	4500	4760	.9	420	455
" 17	13.4	4400	4080	3.6	1100	355
" 18	10.4	4000	5330	.6	150	45
" 19	10.0	4080	4550	.2	630	35
" [illegible]	8.4	3700	6055	1.4	875	345
" 21	10.4	4180	4760	.6	420	135
" [illegible]	11.4	4670	4265	1.6	1015	625
" 23	8.8	3720	5680	1.0	700	325
" 24	7.8	3800	6250	2.0	1070	245
" 25	10.2	4100	4880	.4	300	55
" [illegible]	8.2	3850	5550	1.6	370	195

Tube	Milliamps Initial	Micromhos gm	Ohms rp	Variation from mean Ir	Variation from mean rp	Variation from mean gm
R027	11.4	4470	4760	1.6	420	425
" 28	8.5	4050	6050	1.3	870	5
" 29	10.5	4380	4250	.7	930	335
" 30	10.2	4050	5130	.4	50	5
" 31	10.2	4100	5000	.4	180	55
" 32	9.2	4220	4880	.6	300	175
" 33	9.9	4100	4760	.1	420	55
" 34	8.2	3650	6040	1.6	860	395
" 35	10.3	4230	4800	.4	300	185
" 36	11.0	4150	4445	1.2	735	105
" 37	8.8	3700	5710	1.0	530	345
" 38	10.2	4040	4880	.4	300	5
" 39	9.5	4100	5260	.3	80	55
" 40	8.4	3600	5630	1.4	450	285
Totals	391.9	161810	205405	28.7	10082.5	7800
Average = 1/40 x Totals						
	9.8	4045	5180	.717	266	195

TABLE IX

Average Variation from Mean Value

Tube Group	I_p plate	Weighting Factor	Weighted Mean I_p
Manufacturer "J"			
SA	1.77	34/98	1.77 x 34 = 60.20
SB	1.44	33/98	1.44 x 33 = 47.50
SC	1.80	31/98	1.80 x 31 = 48.30
			sum 156.00
			156.0 ÷ 98 = 1.591
Manufacturer "K"			
RA	.98	9/98	.98 x 9 = 8.82
RB	1.01	26/98	1.01 x 26 = 26.25
RC	1.33	23/98	1.33 x 23 = 30.60
RD	.72	40/98	.72 x 40 = 28.80
			sum 94.47
			94.47 ÷ 98 = .963

TABLE X

Tube Lot	Tube	I_p at E_g of 130 V.	I_p at E_g of 80 V.	I_p at E_g of 65 V.	I_p at E_g of 50 V.	I_p at E_g of 33 V.
	Manufacturers	12.2	7.6	4.0	2.7	.9
	High Tube	15.0	10.3	5.2	3.3	1.0
2A	Low Tube	8.5	4.8	1.97	.95	.15
	Average	11.2	6.55	3.05	1.8	.44
	Manufacturers	12.2	7.6	4.0	2.7	.9
	High Tube	19.0	12.7	6.7	4.4	1.4
2B	Low Tube	11.3	6.8	3.2	1.9	.4
	Average	15.2	9.78	4.96	3.16	.94
	Manufacturers	12.2	7.6	4.0	2.7	.9
	High Tube	14.5	8.9	4.5	2.8	.7
2C	Low Tube	8.8	3.9	1.9	1.0	.15
	Average	11.3	6.44	2.96	1.72	.37

All Values of I_p are Milliamps

Tube Lot	Tube	I_p at E_p of 150 V.	I_p at E_p of 250 V.	I_p at E_p of 90 V.	I_p at E_p of 45 V.	I_p at E_p of 18 V.
	Manufacturers	8.3	5.0	2.2	.75	0
R1	High Tube	13.4	8.3	4.4	1.7	.35
	Low Tube	10.3	6.5	3.4	1.3	.15
	Average	11.7	7.13	4.03	1.57	.283
	Manufacturers	8.3	5.0	2.2	.75	0
R2	High Tube	13.1	8.7	5.1	2.4	.5
	Low Tube	7.7	4.5	2.1	.55	.15
	Average	11.0	6.83	3.44	1.33	.23
	Manufacturers	8.3	5.0	2.2	.75	0
R3	High Tube	11.5	7.5	4.3	1.6	.3
	Low Tube	5.5	2.8	1.3	.4	.1
	Average	9.0	5.28	2.7	.88	.16
	Manufacturers	8.3	5.0	2.2	.75	0
R4	High Tube	13.4	8.5	4.7	1.9	.4
	Low Tube	7.8	4.5	2.0	.5	.05
	Average	9.8	5.86	2.87	.90	.142

All Values of I_p are Milliamps

Item						
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]
[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]	[illegible]

[illegible]

TABLE XI

Sample Calculation of Power Output

Ordinate	Voltage = ord. x 4.5v.	E^2
0	0.0	0.0
.3	1.5	2.2
.4	1.9	3.6
.7	3.9	15.1
1.0	4.9	31.-0
2.7	13.2	165.0
5.0	24.5	600.0
7.0	34.3	1175.0
10.0	49.0	2400.0
13.0	63.6	4030.0
15.0	73.5	5390.0
18.0	88.3	7760.0
20.0	98.0	9600.00
20.5	100.5	10050.0
21.0	103.0	10600.0
21.3	105.3	11 90.0
22.0	107.8	11600.0
22.0	107.8	11600.0
21.7	106.2	11270.0
21.5	105.3	11080.0
22.0	107.8	11600.0

Ordinate	Voltage = ord. x h./v.	E^2
21.0	105.0	11000.0
21.0	105.0	11000.0
20.7	101.4	10272.0
20.1	99.5	9880.0
20.0	98.0	9604.0
19.0	93.1	8700.0
18.0	88.2	7780.0
17.0	83.2	6920.0
16.0	83.7	6570.0
15.0	49.0	2400.0
5.0	24.5	600.0
3.0	14.7	2214.0
1.0	4.9	24.0
.2	.98	.96
0	0.0	0.0
0	0.0	0.0
0	0.0	0.0
0	0.0	0.0
		Total 201469.2

Total E^2 = 201469.2 Average E^2 = $\frac{201469.2}{39}$ = 5030 volts^2

Number of ordinates = 39 $P_{average} = \frac{1}{R} = \frac{5030}{5000} =$ 1.075 Watt

APPENDIX II

TABLE I

Tube	gm before test	Δ gm for 375 Lower Chamber	% change in gm
Sm 1	4200	-2525	60.0
2	4300	-1300	30.2
3	3750	-1575	42.0
4	4950	-1570	31.1
5	4250	-1675	39.6
6	4320	-1370	43.3
7	4250	-1370	32.8
8	4400	-1400	31.8
9	4730	-1530	32.3
10	4050	-1330	32.8
11	4600	-1890	41.1
12	4400	-1700	38.6
13	4350	-1270	29.2
14	4550	-1600	35.2
15	3580	-1110	31.0
16	4600	-1500	32.6
17	4550	-1170	25.7
18	4550	-1850	40.7
20	4330	-1410	34.1
21	4400	-1460	33.2

Tube	gm after test	final relative position of gm (actual)	final relative position of gm (predicted)
[illegible] 1	3160	9th	10th
2	3670	6th	4th
3	3830	10th	9th
4	3960	4th	2nd
5	3820	8th	7th
6	4420	1st	8th
7	3860	7th	5th
8	4300	2nd	3rd
9	4200	3rd	1st
10	3880	5th	6th
11	3930	5th	8th
12	3800	9th	8th
13	3100	4th	3rd
14	3100	4th	4th
15	3850	7th	10th
16	3700	1st	2nd
17	3900	2nd	1st
18	3150	3rd	7th
20	3700	8th	9th
21	3900	6th	5th

1	[illegible]	[illegible]	[illegible]
2	[illegible]	[illegible]	[illegible]
3	[illegible]	[illegible]	[illegible]
4	[illegible]	[illegible]	[illegible]
5	[illegible]	[illegible]	[illegible]
6	[illegible]	[illegible]	[illegible]
7	[illegible]	[illegible]	[illegible]
8	[illegible]	[illegible]	[illegible]
9	[illegible]	[illegible]	[illegible]
10	[illegible]	[illegible]	[illegible]
11	[illegible]	[illegible]	[illegible]
12	[illegible]	[illegible]	[illegible]
13	[illegible]	[illegible]	[illegible]
14	[illegible]	[illegible]	[illegible]
15	[illegible]	[illegible]	[illegible]
16	[illegible]	[illegible]	[illegible]
17	[illegible]	[illegible]	[illegible]
18	[illegible]	[illegible]	[illegible]
19	[illegible]	[illegible]	[illegible]
20	[illegible]	[illegible]	[illegible]
21	[illegible]	[illegible]	[illegible]
22	[illegible]	[illegible]	[illegible]
23	[illegible]	[illegible]	[illegible]
24	[illegible]	[illegible]	[illegible]
25	[illegible]	[illegible]	[illegible]
26	[illegible]	[illegible]	[illegible]
27	[illegible]	[illegible]	[illegible]
28	[illegible]	[illegible]	[illegible]
29	[illegible]	[illegible]	[illegible]
30	[illegible]	[illegible]	[illegible]
31	[illegible]	[illegible]	[illegible]

Tube	Relative position original gp
1	7th
2	5th
3	9th
4	2nd
5	7th
6	3rd
7	6th
8	4th
9	1st
10	8th
11	1st
12	3rd
13	4th
14	2nd
15	6th
16	1st
17	2nd
18	2nd
20	5th
21	3rd

Item	Adjusted vocational preference
1	7.3
2	6.4
3	7.0
4	6.6
5	7.8
6	7.4
7	6.8
8	6.6
9	7.4
10	6.6
11	7.6
12	7.4
13	6.6
14	6.6
15	6.8
16	7.4
17	6.4
18	7.4
19	6.6
20	6.8
21	7.4

TABLE I (continued)

Tube	gm before test	gm for 37% lower Eheater	% change in gm	gm after test
RD 1	3630	825	77.3	3600
2	4300	800	81.3	4270
3	4000	1150	71.3	3700
4	3800	1275	46.2	3730
5	4550	1950	57.1	4600
6	3620	1950	46.2	3300
7	4150	1700	59.0	3950
8	3670	2550	30.5	3520
9	3900	800	79.5	3560
10	4200	660	84.2	4400

	Actual relative gm after test	Predicted relative gm after test	Original relative position of gm
1	7th	10th	9th
2	3rd	5th	2nd
3	6th	6th	5th
4	5th	7th	7th
5	1st	1st	1st
6	10th	4th	10th
7	4th	3rd	4th
8	9th	2nd	8th
9	8th	9th	6th
10	2nd	8th	3rd

TABLE I (continued)

Tube No.	gm before test	gm for 175 Inner Chamber	% change in gm	gm after test
1	3630	[illegible]	77.3	3800
2	4300	800	14.3	4571
3	[illegible]	1140	71.3	3720
4	3300	1177	[illegible]	3750
5	[illegible]	1098	57.1	4400
6	[illegible]	1296	44.2	3720
7	[illegible]	1750	59.6	3398
8	[illegible]	1203	70.7	3520
9	3700	800	77.5	3760
10	[illegible]	640	81.7	4400

	Ranked relative gm after test	Ranked relative gm after test	Original relative position of
1	[illegible]	10th	9th
2	2nd	9th	2nd
3	[illegible]	6th	5th
4	[illegible]	7th	7th
5	1st	1st	1st
6	[illegible]	5th	10th
7	[illegible]	3rd	4th
8	5th	2nd	8th
9	[illegible]	[illegible]	6th
10	[illegible]	8th	3rd

Tube	gm before test	gm for 37% lower Chatter	% change in gm	gm after test
RC 1	3630	605	16.7	3300
2	3450	2900	84.5	3420
3	4550	820	18.0	3750
4	3420	1270	37.2	3600
5	3900	1700	43.6	3850
6	3800	1580	41.6	3320
7	3350	650	19.4	3280
8	3440	1940	56.4	3430
9	3100	2250	72.6	3400
10	3620	2870	79.3	3700

Tubo				
1	3420	867	24.7	3300
2	3420	1901	55.5	3420
3	3300	830	24.6	3360
4	3420	1340	37.5	3600
5	3360	1720	51.4	3360
6	3360	1760	52.4	3360
7	3360	650	19.4	3360
8	3420	1980	57.8	3420
9	3300	2230	71.6	3300
10	3600	2070	58.1	3700

Tube	Actual relative gm after test	Predicted relative gm after test	Original relative position of gm
RS 1	8th	2nd	4th
2	6th	9th	6th
3	2nd	1st	1st
4	4th	6th	8th
5	1st	3rd	2nd
6	9th	4th	3rd
7	10th	5th	9th
8	5th	8th	7th
9	7th	10th	10th
10	3rd	7th	5th

TABLE II

Tube	r_p at 6.3V	r_p at 4.0V	Δr_p
6A 11	3510	6450	2940
12	3420	9100	5680
13	5125	11100	5975
14	4080	5880	1800
15	5125	8710	3585
16	4875	15400	10525
17	4000	10350	6350
18	4545	21050	16505
19	5125	9540	4415
20	4000	8350	4350
8A 1	5260	9520	3260
2	4650	11750	7100
3	3775	14300	10525
4	4080	13330	9250
5	3920	25000	21080
6	4160	9100	4940
8	4250	28600	24350
9	4350	13340	8990
10	4445	18200	13755

12	1764	21168	63504
11	1452	15972	47916
10	1210	12100	36300
9	990	8910	26730
8	704	5632	16896
7	539	3773	11319
6	396	2376	7128
5	275	1375	4125
4	176	704	2816
3	99	297	891
2	44	88	176
1	11	11	11
78	6084	474552	37015056
12	144	1728	20736
11	121	1331	14641
10	100	1000	10000
9	81	729	6561
8	64	512	4096
7	49	343	2401
6	36	216	1296
5	25	125	625
4	16	64	256
3	9	27	81
2	4	8	16
1	1	1	1
91	650	5434	48778

Tube	gm after test	gm before test	Δ gm due 20 hour test
[illegible]11	2730	4170	-1440
12	2900	3900	-1000
13	2630	3270	-640
14	2590	3650	-1060
15	2560	3370	-810
16	2150	3300	-1150
17	2700	3700	-1000
18	2450	3680	-1230
19	2700	3350	-650
20	2830	3600	-770
RA1	3960	4150	-80
2	3700	3860	-170
3	3930	4220	-330
4	4280	4400	-300
5	4730	4850	-120
6	3320	3630	-460
8	3550	4080	-530
9	3950	4320	-370
10	3820	4000	-180

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VITA

The author was born in Norfolk, Virginia in October 1919.

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